

## DLP2000 (0.2 nHD) DMD

### 1 特性

- 超紧凑 0.2 英寸 (5.55mm) 对角线微镜阵列
  - 640 × 360 铝制微米级微镜阵列，采用正交布局
  - 7.56 微米微镜间距
  - 12° 微镜倾斜（相对于平坦表面）
  - 角落照明，实现最优的效率和光学引擎尺寸
- 专用 DLPC2607 显示控制器和 DLPA1000 PMIC/LED 驱动器，确保可靠运行

### 2 应用

- 物联网 (IoT) 器件，包括：
  - 控制面板
  - 安全系统
  - 恒温器
- 可穿戴显示
- 产品嵌入式显示屏，包括：
  - 平板电脑
  - 摄像头
  - 人工智能 (AI) 助理
- 微数字标牌
- 超低功耗智能附件投影仪

### 3 说明

DLP2000 数字微镜器件 (DMD) 是一款数控微光机电系统 (MOEMS) 空间照明调制器 (SLM)。当与适当的光学系统配合使用时，DLP2000 DMD 可显示非常清晰的高质量图像或视频。DLP2000 是 DLP2000 DMD 和 DLPC2607 显示控制器所组成的芯片组的一部分。DLPA1000 PMIC/LED 驱动器也支持此芯片组。DLP2000 紧凑的物理尺寸非常适合于注重小外形尺寸和低功耗的便携式设备。紧凑封装弥补了小尺寸 LED 的不足，从而可实现高效、可靠耐用的光引擎。

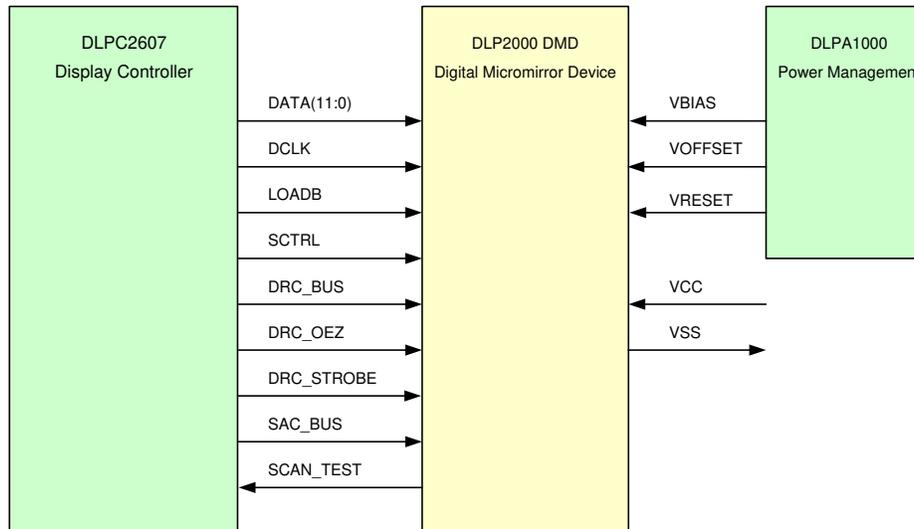
请访问 [TI DLP®Pico™ 显示技术入门页](#)，了解如何开始使用 DLP2000 DMD。

DLP2000 提供成的资源，可帮助用户加快设计周期。这些资源包括 [量产就绪型光学模块](#)、[光学模块制造商](#)和 [设计公司](#)。

#### 器件信息<sup>(1)</sup>

| 器件型号    | 封装       | 封装尺寸 (标称值)       |
|---------|----------|------------------|
| DLP2000 | FQC (42) | 14.12mm × 4.97mm |

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。



简化版应用



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## 4 Revision History

注：以前版本的页码可能与当前版本的页码不同

| <b>Changes from Revision A (November 2021) to Revision B (May 2022)</b> | <b>Page</b> |
|---|-------------|
| • 根据最新的德州仪器 (TI) 和行业数据表标准对本文档进行了更新.....                                 | 1           |
| • Updated <i>Micromirror Array Optical Characteristics</i> .....        | 14          |

| <b>Changes from Revision * (April 2019) to Revision A (November 2021)</b> | <b>Page</b> |
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| • 更新了整个文档中的表格、图和交叉参考的编号格式.....  | 1           |
| • Updated  T <sub>DELTA</sub>   MAX from 30°C to 15°C.....                | 7           |

## 5 Pin Configuration and Functions

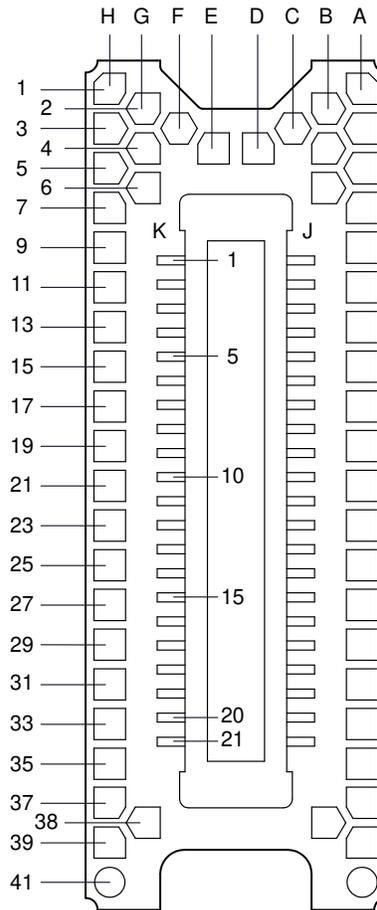


图 5-1. FQC Package 42-Pin LGA Bottom View

表 5-1. Pin Functions

| PIN                   |     | TYPE  | SIGNAL  | DATA RATE | DESCRIPTION                | PACKAGE NET LENGTH (mm) |
|-----------------------|-----|-------|---------|-----------|----------------------------|-------------------------|
| NAME                  | NO. |       |         |           |                            |                         |
| <b>DATA INPUTS</b>    |     |       |         |           |                            |                         |
| DATA(0)               | J13 | Input | LVC MOS | DDR       | Input data bus             | 8.83                    |
| DATA(1)               | J2  | Input | LVC MOS | DDR       | Input data bus             | 7.53                    |
| DATA(2)               | J4  | Input | LVC MOS | DDR       | Input data bus             | 6.96                    |
| DATA(3)               | J6  | Input | LVC MOS | DDR       | Input data bus             | 7.05                    |
| DATA(4)               | J7  | Input | LVC MOS | DDR       | Input data bus             | 7.56                    |
| DATA(5)               | J8  | Input | LVC MOS | DDR       | Input data bus             | 7.07                    |
| DATA(6)               | J12 | Input | LVC MOS | DDR       | Input data bus             | 7.61                    |
| DATA(7)               | J10 | Input | LVC MOS | DDR       | Input data bus             | 7.68                    |
| DATA(8)               | K4  | Input | LVC MOS | DDR       | Input data bus             | 7.31                    |
| DATA(9)               | K2  | Input | LVC MOS | DDR       | Input data bus             | 6.76                    |
| DATA(10)              | K7  | Input | LVC MOS | DDR       | Input data bus             | 8.18                    |
| DATA(11)              | K6  | Input | LVC MOS | DDR       | Input data bus             | 7.81                    |
| DCLK                  | K9  | Input | LVC MOS |           | Input data clock           | 7.78                    |
| <b>CONTROL INPUTS</b> |     |       |         |           |                            |                         |
| LOADB                 | K10 | Input | LVC MOS | DDR       | Parallel latch load enable | 7.64                    |

表 5-1. Pin Functions (continued)

| PIN          |     | TYPE  | SIGNAL  | DATA RATE | DESCRIPTION  | PACKAGE NET LENGTH (mm)             |
|--------------|-----|-------|---------|-----------|--|-------------------------------------|
| NAME         | NO. |       |         |           |  |                                     |
| SCTRL        | K12 | Input | LVC MOS | DDR       | Serial control (sync)  | 8.62                                |
| DRC_BUS      | K14 | Input | LVC MOS |           | Reset control serial bus. synchronous to rising edge of DCLK. Bond pad does not connect to internal pull down.   | 7.28                                |
| DRC_OEZ      | K18 | Input | LVC MOS |           | Active low. Output enable signal for internal reset driver circuitry. Bond pads do not connect to internal pulldown.   | 4.69                                |
| DRC_STROBE   | J15 | Input | LVC MOS |           | Rising edge on DRC_STROBE latches in the control signals. Synchronous to rising edge of DCLK. Bond pad does not connect to internal pulldown.                                      | 7.61                                |
| SAC_BUS      | K16 | Input | LVC MOS |           | Stepped address control serial bus. Synchronous to rising edge of DCLK. Bond pad does not connect to internal pulldown.  | 8.17                                |
| SCAN_TEST    | K20 | Input | LVC MOS |           | MUX' ed output for scanned chip ID   | 1.18                                |
| <b>POWER</b> |     |       |         |           |  |                                     |
| VBIAS        | J16 | Power |         |           | Power supply for positive bias level of mirror reset signal  |                                     |
| VOFFSET      | K15 | Power |         |           | Power supply for high voltage CMOS logic. Power supply for stepped high voltage at mirror address electrodes. Power supply for offset level of mirror reset signal                 |                                     |
| VRESET       | J20 | Power |         |           | Power supply for negative reset level of mirror reset signal   |                                     |
| VCC          | J1  | Power |         |           | Power supply for low voltage CMOS logic. Power supply for normal high voltage at mirror address electrodes. Power supply for offset level of mirror reset signal during power down |                                     |
| VCC          | J11 | Power |         |           |  |                                     |
| VCC          | J21 | Power |         |           |  |                                     |
| VCC          | K1  | Power |         |           |  |                                     |
| VCC          | K11 | Power |         |           |  |                                     |
| VCC          | K21 | Power |         |           |  |                                     |
| VSS          | J3  | Power |         |           |  | Common return. Ground for all power |
| VSS          | J5  | Power |         |           |  |                                     |
| VSS          | J9  | Power |         |           |  |                                     |
| VSS          | J14 | Power |         |           |  |                                     |
| VSS          | J17 | Power |         |           |  |                                     |
| VSS          | J18 | Power |         |           |  |                                     |
| VSS          | J19 | Power |         |           |  |                                     |
| VSS          | K3  | Power |         |           |  |                                     |
| VSS          | K5  | Power |         |           |  |                                     |
| VSS          | K8  | Power |         |           |  |                                     |
| VSS          | K13 | Power |         |           |  |                                     |
| VSS          | K17 | Power |         |           |  |                                     |
| VSS          | K19 | Power |         |           |  |                                     |

**Pin Functions—Test Pads**

| Electrical Test Pad | DLP® System Board |
|---------------------|-------------------|
| A1                  | Do not connect.   |
| A3                  | Do not connect.   |
| A5                  | Do not connect.   |
| A7                  | Do not connect.   |
| A9                  | Do not connect.   |
| A11                 | Do not connect.   |
| A13                 | Do not connect.   |
| A15                 | Do not connect.   |
| A17                 | Do not connect.   |
| A19                 | Do not connect.   |
| A21                 | Do not connect.   |
| A23                 | Do not connect.   |
| A25                 | Do not connect.   |
| A27                 | Do not connect.   |
| A29                 | Do not connect.   |
| A31                 | Do not connect.   |
| A33                 | Do not connect.   |
| A35                 | Do not connect.   |
| A37                 | Do not connect.   |
| A39                 | Do not connect.   |
| A41                 | Do not connect.   |
| B2                  | Do not connect.   |
| B4                  | Do not connect.   |
| B6                  | Do not connect.   |
| B38                 | Do not connect.   |
| C3                  | Do not connect.   |
| D4                  | Do not connect.   |
| E4                  | Do not connect.   |
| F3                  | Do not connect.   |
| G2                  | Do not connect.   |
| G4                  | Do not connect.   |
| G6                  | Do not connect.   |
| G38                 | Do not connect.   |
| H1                  | Do not connect.   |
| H3                  | Do not connect.   |
| H5                  | Do not connect.   |
| H7                  | Do not connect.   |
| H9                  | Do not connect.   |
| H11                 | Do not connect.   |
| H13                 | Do not connect.   |
| H15                 | Do not connect.   |
| H17                 | Do not connect.   |
| H19                 | Do not connect.   |
| H21                 | Do not connect.   |
| H23                 | Do not connect.   |

### Pin Functions—Test Pads (continued)

| Electrical Test Pad | DLP® System Board |
|---------------------|-------------------|
| H25                 | Do not connect.   |
| H27                 | Do not connect.   |
| H29                 | Do not connect.   |
| H31                 | Do not connect.   |
| H33                 | Do not connect.   |
| H35                 | Do not connect.   |
| H37                 | Do not connect.   |
| H39                 | Do not connect.   |
| H41                 | Do not connect.   |

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                 |                              |   | MIN   | MAX                       | UNIT |
|-----------------|------------------------------|---|-------|---------------------------|------|
| Supply Voltage  | $V_{CC}$                     | LVC MOS logic supply voltage <sup>(2)</sup>   | - 0.5 | 4                         | V    |
|                 | $V_{OFFSET}$                 | Mirror electrode and HVCMOS voltage <sup>(2)</sup>  | - 0.5 | 8.75                      | V    |
|                 | $V_{BIAS}$                   | Mirror electrode voltage  | - 0.5 | 17                        | V    |
|                 | $ V_{BIAS} - V_{OFFSET} $    | Supply voltage delta <sup>(3)</sup>   |       | 8.75                      | V    |
|                 | $V_{RESET}$                  | Mirror electrode voltage  | - 11  | 0.5                       | V    |
| Input Voltage   | Input voltage: other inputs  | See <sup>(2)</sup> .  | - 0.5 | $V_{CC} + 0.3$            | V    |
| Clock Frequency | $D_{CLK}$                    | Clock frequency   | 60    | 80                        | MHz  |
| Environmental   | $T_{ARRAY}$ and $T_{WINDOW}$ | Temperature—operational <sup>(4)</sup>  | - 20  | 90                        | °C   |
|                 |                              | Temperature—non-operational <sup>(4)</sup>  | - 40  | 90                        | °C   |
|                 | $T_{DP}$                     | Dew point temperature—operating and non-operating (non-condensing)  |       | See note <sup>(5)</sup> . | °C   |
|                 | $ T_{DELTA} $                | Absolute temperature delta between any point on the window edge and the ceramic test point TP1 <sup>(6)</sup> |       | 30                        | °C   |

- Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- All voltage values are with respect to GND ( $V_{SS}$ ).  $V_{OFFSET}$ ,  $V_{CC}$ ,  $V_{BIAS}$ ,  $V_{RESET}$  and  $V_{SS}$  power supplies are required for the normal DMD operating mode.
- To prevent excess current, the supply voltage delta  $|V_{BIAS} - V_{OFFSET}|$  must be less than 8.75 V.
- The highest temperature of the active array (as calculated in [§ 7.6](#)) or of any point along the Window Edge as defined in [Fig 7-1](#).
- The DLP2000 DMD is intended for use in well controlled, low dew point environments. Please contact your local TI sales person or TI distributor representative to determine if this device is suitable for your application and operating environment compared to other DMD solutions. DLP® Products offers a broad portfolio of DMDs suitable for a wide variety of applications.
- Temperature delta is the highest difference between the ceramic test point 1 (TP1) and anywhere on the window edge as shown in [Fig 7-1](#).

### 6.2 Storage Conditions

Applicable before the DMD is installed in the final product

|           |                 | MIN  | MAX | UNIT |
|-----------|-----------------|------|-----|------|
| $T_{DMD}$ | DMD Temperature | - 40 | 85  | °C   |

## 6.2 Storage Conditions (continued)

Applicable before the DMD is installed in the final product

|                 |                       | MIN              | MAX | UNIT                          |
|-----------------|-----------------------|------------------|-----|-------------------------------|
| T <sub>DP</sub> | Dew Point Temperature | (non-condensing) |     | See Note <sup>(1)</sup><br>°C |

- (1) The DLP2000 DMD is intended for use in well controlled, low dew point environments. Please contact your local TI sales person or TI distributor representative to determine if this device is suitable for your application and operating environment compared to other DMD solutions. DLP Products offers a broad portfolio of DMDs suitable for a wide variety of applications.

## 6.3 ESD Ratings

|                    |                         | VALUE   | UNIT       |
|--------------------|-------------------------|---|------------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup> | ±2000<br>V |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 6.4 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)

|                    |                                  | MIN  | NOM   | MAX                        | UNIT     |                     |                    |
|--------------------|----------------------------------|--|-------|----------------------------|----------|---------------------|--------------------|
| Supply Voltage     | V <sub>CC</sub>                  | LVCMOS logic power supply voltage <sup>(1)</sup>   |       | 1.65                       | 1.8      | 1.95                | V                  |
|                    | V <sub>OFFSET</sub>              | Mirror electrode and HVCMOS voltage <sup>(1)</sup>   |       | 8.25                       | 8.5      | 8.75                | V                  |
|                    | V <sub>BIAS</sub>                | Mirror electrode voltage   |       | 15.5                       | 16       | 16.5                | V                  |
|                    |                                  | Supply voltage delta  V <sub>BIAS</sub> - V <sub>OFFSET</sub>   <sup>(2)</sup>                                     |       |                            |          | 8.75                | V                  |
| V <sub>RESET</sub> | Mirror electrode voltage         |  | - 9.5 | - 10                       | - 10.5   | V                   |                    |
| Input Voltage      | V <sub>P</sub>                   | Positive going threshold voltage   |       | 0.4*V <sub>CC</sub>        |          | 0.7*V <sub>CC</sub> | V                  |
|                    | V <sub>N</sub>                   | Negative going threshold voltage   |       | 0.3*V <sub>CC</sub>        |          | 0.6*V <sub>CC</sub> | V                  |
|                    | V <sub>H</sub>                   | Hysteresis voltage (V <sub>p</sub> - V <sub>n</sub> )  |       | 0.1*V <sub>CC</sub>        |          | 0.4*V <sub>CC</sub> | V                  |
| Environmental      | T <sub>ARRAY</sub>               | Array temperature—long-term operational <sup>(3) (4) (5) (6)</sup>   |       | 0                          | 40 to 70 |                     | °C                 |
|                    |                                  | Array Temperature - short-term operational <sup>(4) (7)</sup>  |       | - 20                       | 75       |                     | °C                 |
|                    | T <sub>DELTA</sub>               | Absolute temperature difference between any point on the window edge and the ceramic test point TP1 <sup>(8)</sup> |       |                            |          | 15                  | °C                 |
|                    | T <sub>WINDOW</sub>              | Window temperature—operational <sup>(3) (9)</sup>  |       |                            |          | 90                  | °C                 |
|                    | T <sub>DP</sub>                  | Dew point temperature (non-condensing)   |       | See note <sup>(10)</sup> . |          |                     | °C                 |
|                    | ILL <sub>UV</sub>                | Illumination wavelength < 400 nm <sup>(3)</sup>  |       |                            |          | 0.68                | mW/cm <sup>2</sup> |
|                    | ILL <sub>VIS</sub>               | Illumination wavelengths between 400 nm and 700 nm   |       | Thermally limited          |          |                     |                    |
| ILL <sub>IR</sub>  | Illumination wavelength > 700 nm |  |       |                            | 10       | mW/cm <sup>2</sup>  |                    |

- (1) All voltage values are with respect to GND (V<sub>SS</sub>). V<sub>OFFSET</sub>, V<sub>CC</sub>, V<sub>BIAS</sub>, V<sub>RESET</sub>, and V<sub>SS</sub> power supplies are required for the normal DMD operating mode.
- (2) To prevent excess current, the supply voltage delta |V<sub>BIAS</sub> - V<sub>OFFSET</sub>| must be less than 8.75 V.
- (3) Simultaneous exposure of the DMD to the maximum [Recommended Operating Conditions](#) for temperature and UV illumination reduces device lifetime.
- (4) The array temperature cannot be measured directly and must be computed analytically from the temperature measured at test point 1 (TP1) shown in [Figure 7-1](#) and the package thermal resistance in [Section 7.6](#).
- (5) Per [Figure 6-1](#), the maximum operational array temperature should be derated based on the micromirror landed duty cycle that the DMD experiences in the end application. Refer to [Section 7.7](#) for a definition of micromirror landed duty cycle.
- (6) Long-term is defined as the usable life of the device
- (7) Array temperatures beyond those specified as long-term are recommended for short-term conditions only (power-up). Short-term is defined as cumulative time over the usable life of the device and is less than 500 hours for temperatures between the long-term maximum and 75°C, and less than 500 hours for temperatures between 0°C and - 20°C.
- (8) Temperature delta is the highest difference between the ceramic test point 1 (TP1) and anywhere on the window edge as shown in [Figure 7-1](#).
- (9) Window temperature is the highest temperature on the window edge shown in [Figure 7-1](#).
- (10) The DLP2000 DMD is intended for use in well controlled, low dew point environments. Please contact your local TI sales person or TI distributor representative to determine if this device is suitable for your application and operating environment compared other DMD solutions. DLP Products offers a broad portfolio of DMDs suitable for a wide variety of applications.

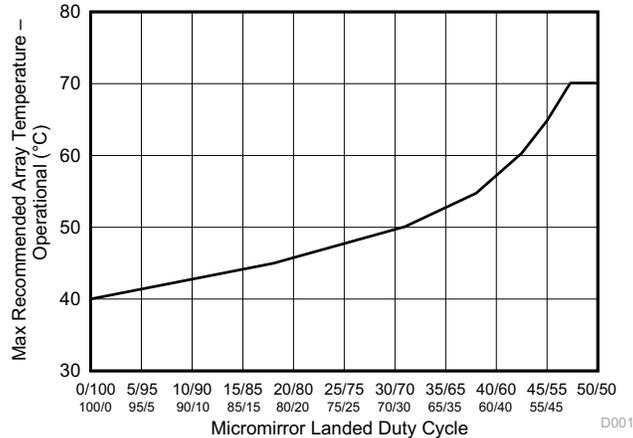


图 6-1. Max Recommended Array Temperature—Derating Curve

## 6.5 Thermal Information

| THERMAL METRIC <sup>(1)</sup>                                       | DLP2000   | UNIT |
|---|-----------|------|
|   | FQC (LGA) |      |
|   | 42 PINS   |      |
| Thermal resistance active area to test point 1 (TP1) <sup>(1)</sup> | 8         | °C/W |

- (1) The DMD is designed to conduct absorbed and dissipated heat to the back of the package. The cooling system must be capable of maintaining the package within the temperature range specified in 节 6.4. The total heat load on the DMD is largely driven by the incident light absorbed by the active area; although other contributions include light energy absorbed by the window aperture and electrical power dissipation of the array. Optical systems should be designed to minimize the light energy falling outside the window aperture since any additional thermal load in this area can significantly degrade the reliability of the device.

## 6.6 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

| PARAMETER           | TEST CONDITIONS   | MIN  | TYP | MAX  | UNIT |
|---------------------|---|------|-----|------|------|
| V <sub>OH</sub>     | High level output voltage<br>V <sub>CC</sub> = 1.65 V<br>I <sub>OH</sub> = - 2 mA                           | 1.20 |     |      | V    |
| V <sub>OL</sub>     | Low level output voltage<br>V <sub>CC</sub> = 1.95 V<br>I <sub>OL</sub> = - 2 mA                            |      |     | 0.45 | V    |
| I <sub>IL</sub>     | Low level input current <sup>(1) (2)</sup><br>V <sub>CC</sub> = 1.95 V<br>V <sub>I</sub> = 0 V              |      |     | 52   | nA   |
| I <sub>IH</sub>     | High level input current <sup>(1) (2)</sup><br>V <sub>CC</sub> = 1.95 V<br>V <sub>I</sub> = 1.95 V          | 41   |     |      | nA   |
| <b>CURRENT</b>      |   |      |     |      |      |
| I <sub>CC</sub>     | Current at V <sub>CC</sub> = 1.95 V<br>D <sub>CLK</sub> Frequency = 77 MHz                                  |      |     | 30   | mA   |
| I <sub>OFFSET</sub> | Current at V <sub>OFFSET</sub> = 8.75 V <sup>(3)</sup>  |      |     | 1.5  | mA   |
| I <sub>BIAS</sub>   | Current at V <sub>BIAS</sub> = 16.5 V <sup>(3) (4)</sup><br>Three global resets within time period = 200 μs |      |     | 1.3  | mA   |
| I <sub>RESET</sub>  | Current at V <sub>RESET</sub> = - 10.5 V<br>Three global resets within time period = 200 μs                 |      |     | 1.2  | mA   |
| <b>POWER</b>        |   |      |     |      |      |
| P <sub>CC</sub>     | Power at V <sub>CC</sub> = 1.95 V <sup>(5)</sup><br>D <sub>CLK</sub> Frequency = 77 MHz                     |      | 26  | 59   | mW   |
| P <sub>OFFSET</sub> | Power at V <sub>OFFSET</sub> = 8.75 V <sup>(5)</sup>  |      | 5   | 13   | mW   |
| P <sub>BIAS</sub>   | Power at V <sub>BIAS</sub> = 16.5 V <sup>(5)</sup><br>Three global resets within time period = 200 μs       |      | 9   | 22   | mW   |
| P <sub>RESET</sub>  | Power at V <sub>RESET</sub> = - 10.5 V <sup>(5)</sup><br>Three global resets within time period = 200 μs    |      | 4   | 13   | mW   |
| P <sub>TOTAL</sub>  | Supply power dissipation total  |      | 44  | 107  | mW   |
| <b>CAPACITANCE</b>  |   |      |     |      |      |
| C <sub>IN</sub>     | Input capacitance<br>f = 1 MHz  |      |     | 10   | pF   |

## 6.6 Electrical Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

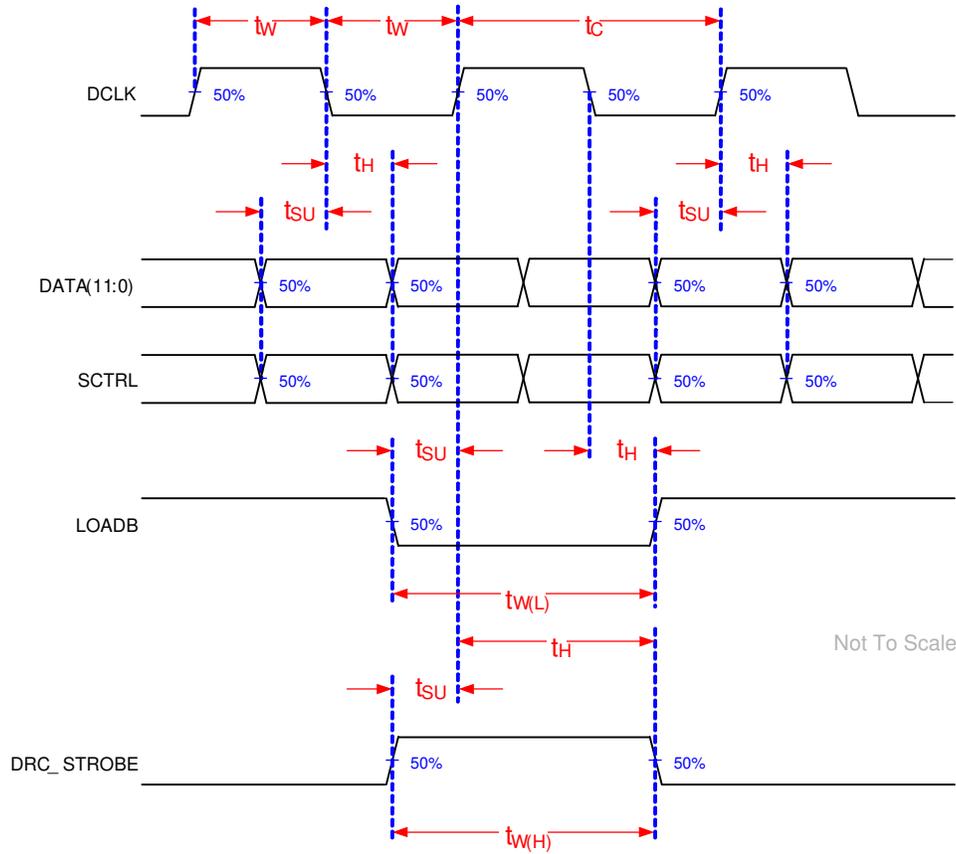
| PARAMETER        |                    | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------|--------------------|-----------------|-----|-----|-----|------|
| C <sub>OUT</sub> | Output capacitance | f = 1 MHz       |     |     | 10  | pF   |

- (1) Includes LVCMOS pins only
- (2) LVCMOS input pins do not have pullup or pulldown configurations.
- (3) To prevent excess current, the supply voltage delta  $|V_{BIAS} - V_{OFFSET}|$  must be less than 8.75 V.
- (4) When DRC\_OEZ = high, the internal reset drivers are tri-stated and I<sub>BIAS</sub> standby current is 3.8 mA.
- (5) Nominal values are measured with V<sub>CC</sub> = 1.8 V, V<sub>OFFSET</sub> = 8.5 V, V<sub>BIAS</sub> = 16 V, and V<sub>RESET</sub> = - 10 V.

## 6.7 Timing Requirements

|                 |                                    |  | MIN  | NOM | MAX   | UNIT |
|-----------------|------------------------------------|--|------|-----|-------|------|
| t <sub>r</sub>  | Rise time <sup>(1)</sup>           | 20% to 80% DCLK                                  |      |     | 2.5   | ns   |
| t <sub>f</sub>  | Fall time <sup>(1)</sup>           | 80% to 20% DCLK                                  |      |     | 2.5   | ns   |
| t <sub>r</sub>  | Rise time <sup>(2)</sup>           | 20% to 80% DATA(11:0), SCTRL, LOADB              |      |     | 2.5   | ns   |
| t <sub>f</sub>  | Fall time <sup>(2)</sup>           | 80% to 20% DATA(11:0), SCTRL, LOADB              |      |     | 2.5   | ns   |
| t <sub>c</sub>  | Cycle time <sup>(1)</sup>          | 50% to 50% DCLK                                  | 12.5 |     | 16.67 | ns   |
| t <sub>w</sub>  | Pulse duration <sup>(1)</sup>      | 50% to 50% DCLK                                  | 5    |     |       | ns   |
| t <sub>w</sub>  | Pulse duration low <sup>(1)</sup>  | 50% to 50% LOADB                                 | 7    |     |       | ns   |
| t <sub>w</sub>  | Pulse duration high <sup>(1)</sup> | 50% to 50% DRC_STROBE                            | 7    |     |       | ns   |
| t <sub>su</sub> | Setup time <sup>(1)</sup>          | DATA(11:0) before rising or falling edge of DCLK | 1    |     |       | ns   |
| t <sub>su</sub> | Setup time <sup>(1)</sup>          | SCTRL before rising or falling edge of DCLK      | 1    |     |       | ns   |
| t <sub>su</sub> | Setup time <sup>(1)</sup>          | LOADB low before rising edge of DCLK             | 1    |     |       | ns   |
| t <sub>su</sub> | Setup time <sup>(2)</sup>          | SAC_BUS low before rising edge of DCLK           | 2    |     |       | ns   |
| t <sub>su</sub> | Setup time <sup>(2)</sup>          | DRC_BUS high before rising edge of DCLK          | 2    |     |       | ns   |
| t <sub>su</sub> | Setup time <sup>(1)</sup>          | DRC_STROBE high before rising edge of DCLK       | 2    |     |       | ns   |
| t <sub>h</sub>  | Hold time <sup>(1)</sup>           | DATA(11:0) after rising or falling edge of DCLK  | 1    |     |       | ns   |
| t <sub>h</sub>  | Hold time <sup>(1)</sup>           | SCTRL after rising or falling edge of DCLK       | 1    |     |       | ns   |
| t <sub>h</sub>  | Hold time <sup>(1)</sup>           | LOADB low after falling edge of DCLK             | 1    |     |       | ns   |
| t <sub>h</sub>  | Hold time <sup>(2)</sup>           | SAC_BUS low after rising edge of DCLK            | 2    |     |       | ns   |
| t <sub>h</sub>  | Hold time <sup>(2)</sup>           | DRC_BUS after rising edge of DCLK                | 2    |     |       | ns   |
| t <sub>h</sub>  | Hold time <sup>(1)</sup>           | DRC_STROBE after rising edge of DCLK             | 2    |     |       | ns   |

- (1) Refer to [图 6-2](#) and [图 6-3](#).
- (2) Refer to [图 6-4](#) and [图 6-5](#).



Not To Scale

图 6-2. Switching Parameters 1

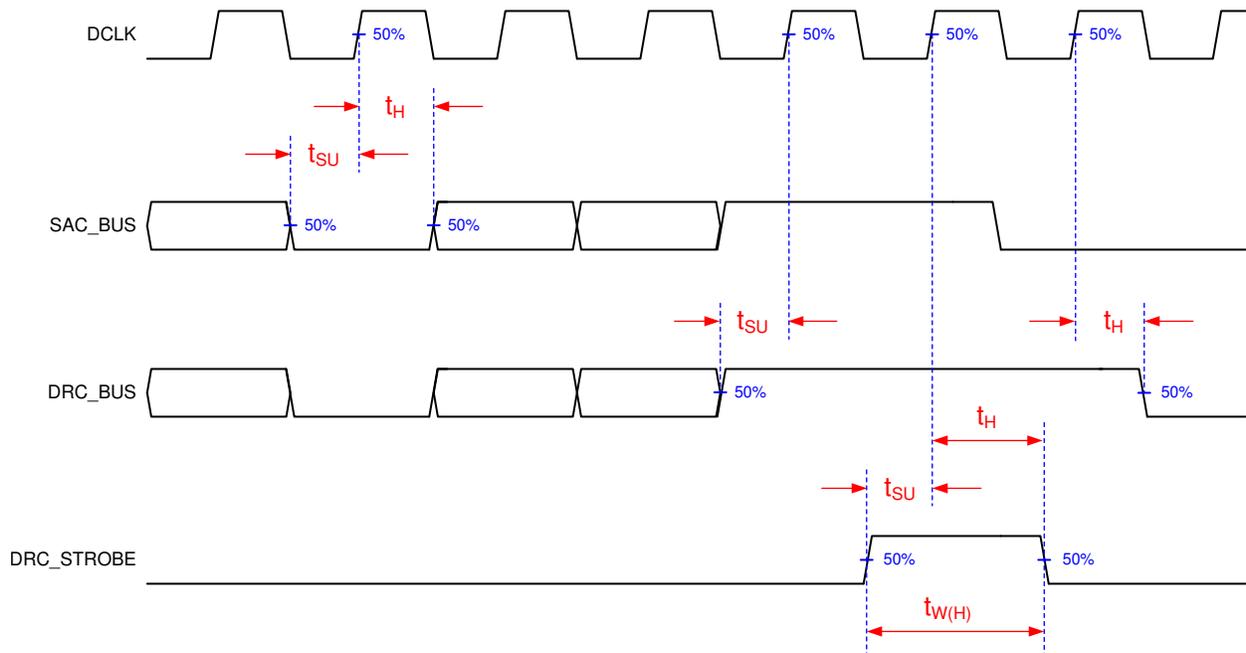


图 6-3. Switching Parameters 2

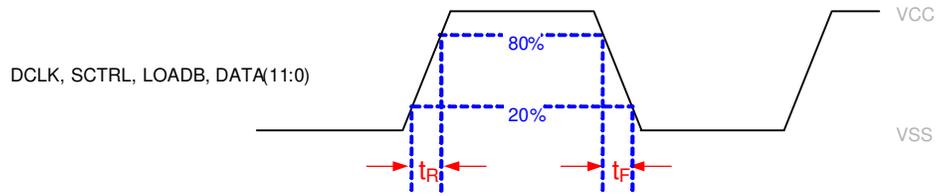


图 6-4. Rise and Fall Timing Parameters 1

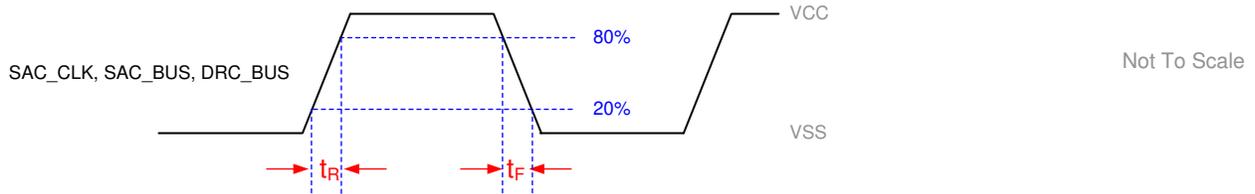


图 6-5. Rise and Fall Timing Parameters 2

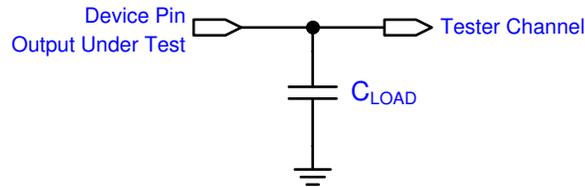


图 6-6. Test Load Circuit

See [§ 7.3.4](#) for more information.

## 6.8 System Mounting Interface Loads

over operating free-air temperature range (unless otherwise noted)

| PARAMETER  |  | MIN | NOM | MAX | UNIT |
|--|--|-----|-----|-----|------|
| Maximum system mounting interface load to be applied to the: | Connector area (See <a href="#">图 6-7.</a> )                                       |     |     | 45  | N    |
|  | DMD mounting area uniformly distributed over 4 areas (See <a href="#">图 6-7.</a> ) |     |     | 100 | N    |

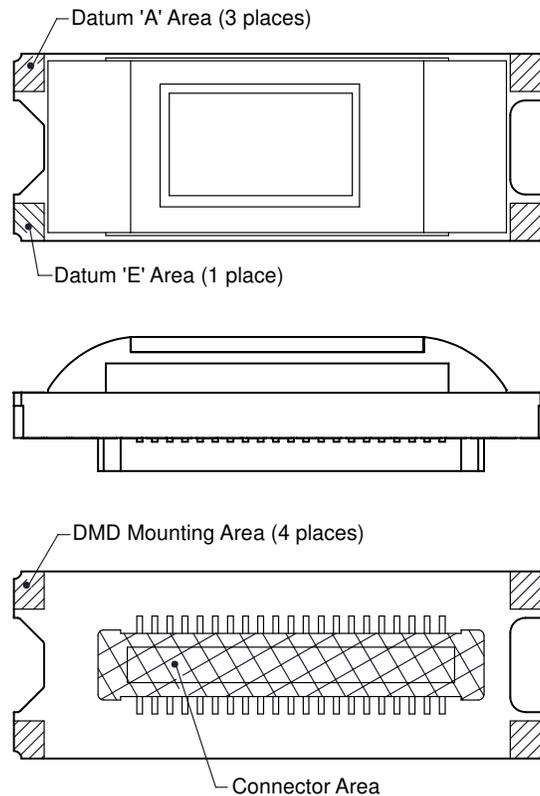


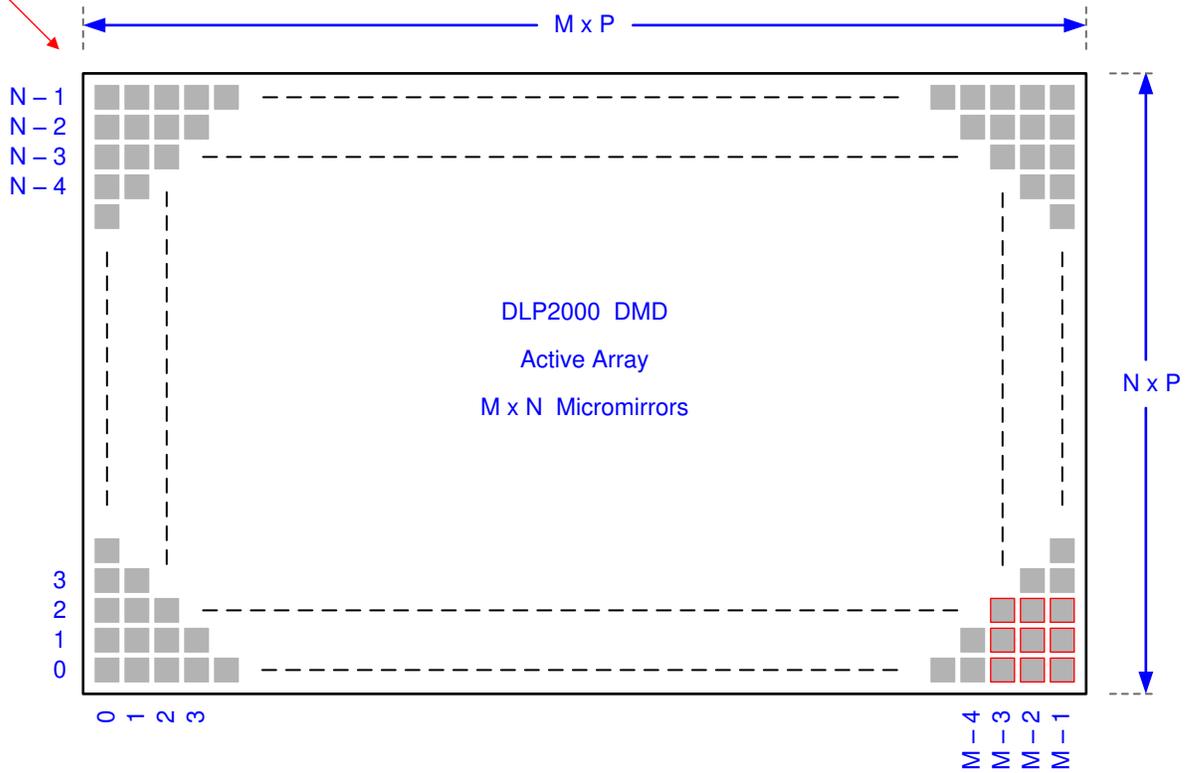
图 6-7. System Interface Loads

## 6.9 Physical Characteristics of the Micromirror Array

| PARAMETER |  | VALUE                      | UNIT                    |
|-----------|--|----------------------------|-------------------------|
| M         | Number of active columns <sup>(1)</sup>        | See 图 6-8.                 | 640<br>micromirrors     |
| N         | Number of active rows <sup>(1)</sup>           | See 图 6-8.                 | 360<br>micromirrors     |
| P         | Micromirror (pixel) pitch <sup>(1)</sup>       | See 图 6-8.                 | 7.56<br>μm              |
|           | Micromirror active array width <sup>(1)</sup>  | $M \times P$               | 4.8384<br>mm            |
|           | Micromirror active array height <sup>(1)</sup> | $N \times P$               | 2.7216<br>mm            |
|           | Micromirror active border <sup>(2) (3)</sup>   | Pond of micromirrors (POM) | 8<br>micromirrors, side |

- (1) See 图 6-8.
- (2) The structure and qualities of the border around the active array include a band of partially functional micromirrors called the “pond of micromirrors” (POM). These micromirrors are structurally and/or electrically prevented from tilting toward the bright or “on” state but still require an electrical bias to tilt toward “off.”
- (3) Out of the eight POM rows on the top and bottom, only the one POM row closest to the active array is electrically attached to that reset group. The other seven POM rows are attached to a dedicated POM internal reset driver circuit.

incident  
illumination



Pond Of Micromirrors (POM) omitted for clarity.

Details omitted for clarity.

Not to scale.

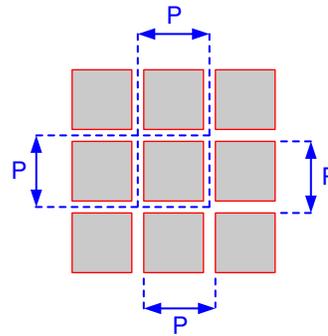


图 6-8. Micromirror Array Physical Characteristics

## 6.10 Micromirror Array Optical Characteristics

| PARAMETER   |   | TEST CONDITIONS               | MIN | NOM | MAX | UNIT         |
|---|---|-------------------------------|-----|-----|-----|--------------|
| Micromirror tilt—half angle, variation device to device <sup>(1)</sup>                    |   |                               | 11  | 12  | 13  | °            |
| Axis of rotation with respect to system datums, variation device to device <sup>(2)</sup> |   |                               | 44  | 45  | 46  | °            |
| Image performance <sup>(3)</sup>  | Bright pixel(s) in active area <sup>(4)</sup>   | Gray 10 screen <sup>(5)</sup> |     |     | 0   | micromirrors |
|   | Bright pixel(s) in the POM <sup>(6)</sup>       | Gray 10 screen <sup>(5)</sup> |     |     | 1   |              |
|   | Dark pixel(s) in the active area <sup>(7)</sup> | White screen                  |     |     | 4   |              |
|   | Adjacent pixel(s) <sup>(8)</sup>                | Any screen                    |     |     | 0   |              |
|   | Unstable pixel(s) in active area <sup>(9)</sup> | Any screen                    |     |     | 0   |              |

- (1) Limits on variability of micromirror tilt half angle are critical in the design of the accompanying optical system. Variations in tilt angle within a device may result in apparent non-uniformities, such as line pairing and image mottling, across the projected image. Variations in the average tilt angle between devices may result in colorimetry and system contrast variations. The specified limits represent the tolerances of the tilt angles within a device.
- (2) See [Fig 6-9](#).
- (3) Conditions of acceptance: All DMD image quality returns are evaluated using the following projected image test conditions:  
 Test set degamma should be linear.  
 Test set brightness and contrast should be set to nominal.  
 The diagonal size of the projected image should be a minimum of 20 inches.  
 The projections screen should be 1X gain.  
 The projected image should be inspected from a 38-inch minimum viewing distance.  
 The image should be in focus during all image quality tests.
- (4) Bright pixel definition: A single pixel or mirror that is stuck in the ON position and is visibly brighter than the surrounding pixels
- (5) Gray 10 screen definition: All areas of the screen are colored with the following settings:  
 Red = 10/255  
 Green = 10/255  
 Blue = 10/255
- (6) POM definition: Rectangular border of off-state mirrors surrounding the active area
- (7) Dark pixel definition: A single pixel or mirror that is stuck in the OFF position and is visibly darker than the surrounding pixels
- (8) Adjacent pixel definition: Two or more stuck pixels sharing a common border or common point, also referred to as a cluster
- (9) Unstable pixel definition: A single pixel or mirror that does not operate in sequence with parameters loaded into memory. The unstable pixel appears to be flickering asynchronously with the image.

Pond Of Micromirrors (POM) omitted for clarity.

Details omitted for clarity. Not to scale.

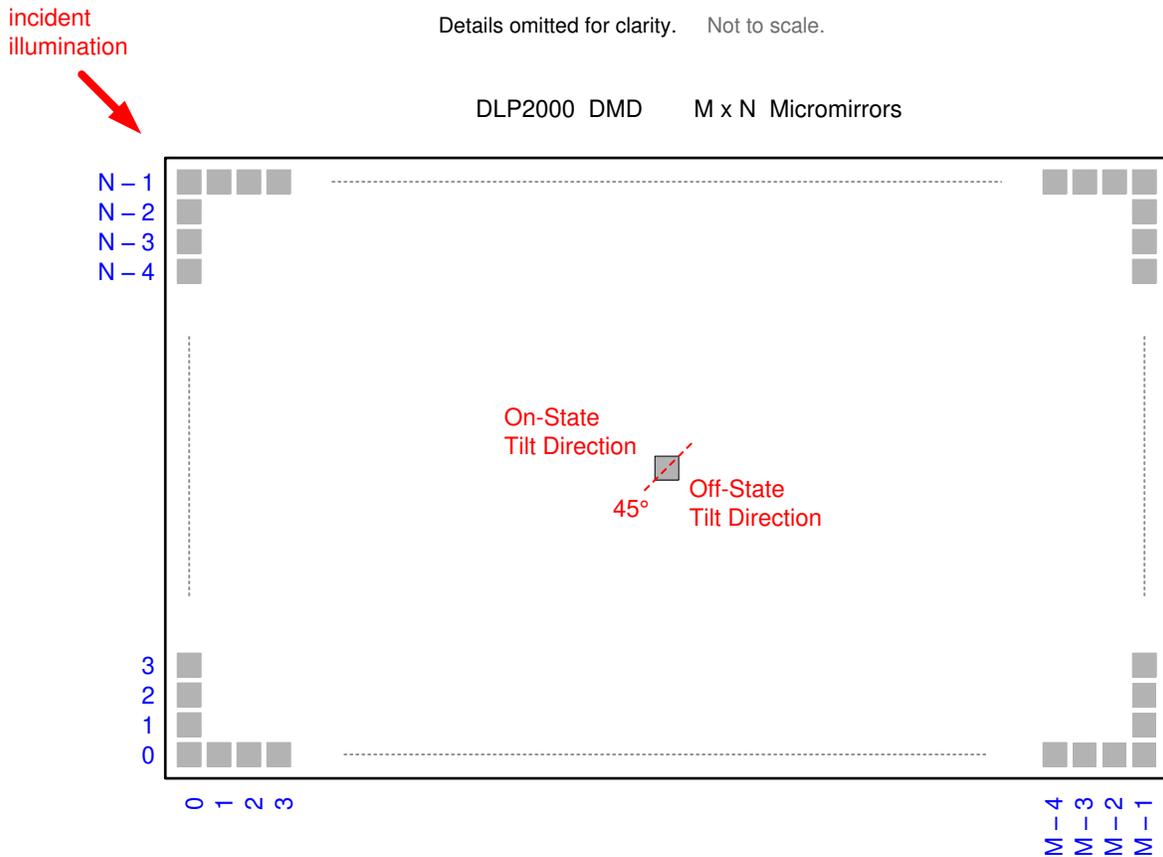


图 6-9. Landed Pixel Orientation and Tilt

See 节 6.9 for M and N specifications.

## 6.11 Window Characteristics

表 6-1. DMD Window Characteristics

| PARAMETER  | VALUE            | UNIT |
|--|------------------|------|
| Window Material  | Corning Eagle XG |      |
| Window Refractive Index at wavelength 546.1 nm   | 1.5119           |      |
| Window Transmittance, minimum within the wavelength range 420 - 680 nm. Applies to all angles 0 - 30° AOI. (1) (2) | 97%              |      |
| Window Transmittance, average over the wavelength range 420 - 680 nm. Applies to all angles 30 - 45° AOI. (1) (2)  | 97%              |      |

(1) Single-pass through both surfaces and glass.

(2) AOI - Angle Of Incidence is the angle between an incident ray and the normal of a reflecting or refracting surface.

## 6.12 Chipset Component Usage Specification

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### 备注

TI assumes no responsibility for image quality artifacts or DMD failures caused by optical system operating conditions exceeding limits described previously.

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The DLP2000 is a component of one or more DLP chipsets. Reliable function and operation of the DLP2000 requires that it be used in conjunction with the other components of the applicable DLP chipset, including those components that contain or implement TI DMD control technology. TI DMD control technology is the TI technology and devices for operating or controlling a DLP DMD.

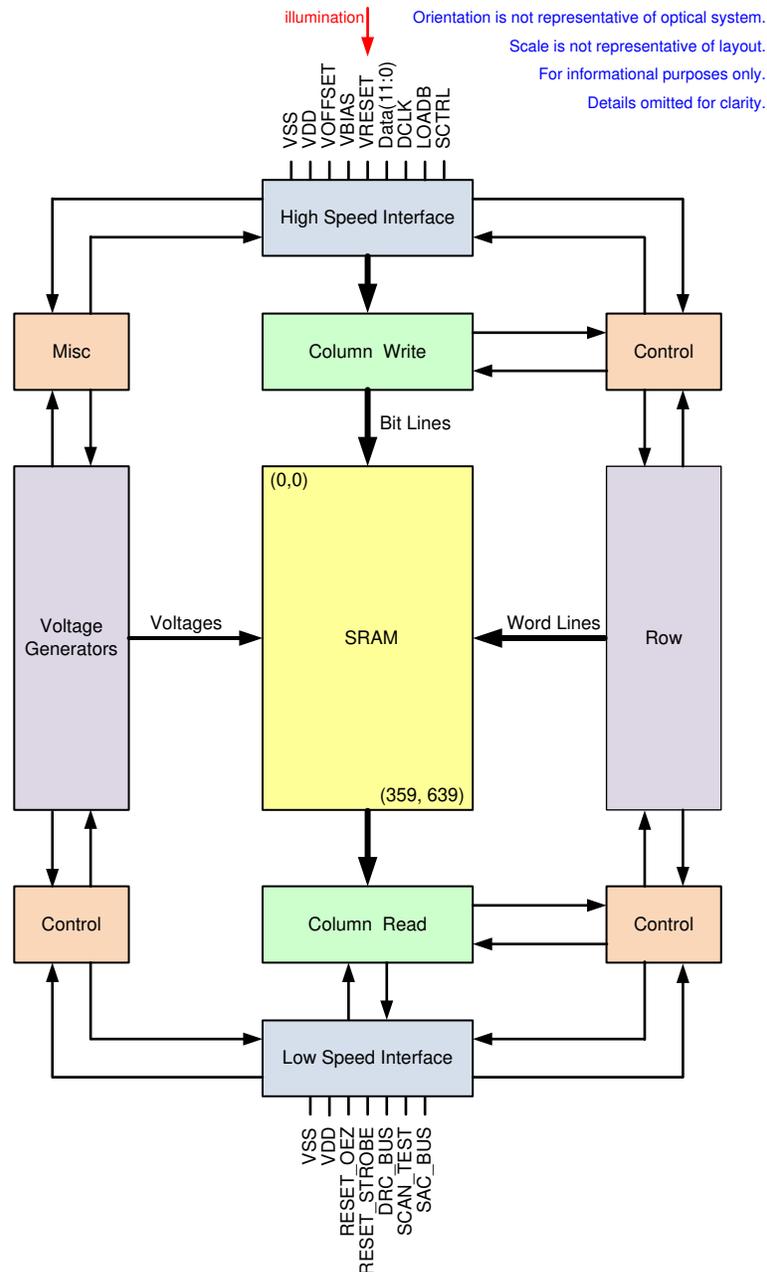
## 7 Detailed Description

### 7.1 Overview

The DLP2000 is a 0.2-inch diagonal spatial light modulator of aluminum micromirrors. Pixel array size is 640 columns by 360 rows in a square grid pixel arrangement. The DMD is an electrical input, optical output micro-electrical-mechanical system (MEMS). The electrical interface is a Double Data Rate (DDR) input data bus.

The DLP2000 is part of the chipset that includes the DLP2000 DMD, the DLPC2607 display controller, and the DLPA1000 PMIC/LED driver. To ensure optimal performance, the DLP2000 DMD should be used with the DLPC2607 display controller and the DLPA1000 PMIC/LED driver.

### 7.2 Functional Block Diagram



## 7.3 Feature Description

### 7.3.1 Power Interface

For the DLP2000 DMD, the power management IC is the DLPA1000. This driver contains three regulated DC supplies for the DMD reset circuitry:  $V_{BIAS}$ ,  $V_{RESET}$ , and  $V_{OFFSET}$ .

### 7.3.2 Control Serial Interface

The control serial interface handles instructions that configure the DMD and control reset operation. DRC\_BUS is the reset control serial bus, DRC\_OEZ is the active low, output enable signal for internal reset driver circuitry, DRC\_STROBE rising edge latches in the control signals, and SAC\_BUS is the stepped address control serial bus.

### 7.3.3 High Speed Interface

The purpose of the high-speed interface is to transfer pixel data rapidly and efficiently, making use of high speed DDR transfer and compression techniques to save power and time. The high speed interface is composed of LVCMOS signal receivers for inputs and a dedicated clock.

### 7.3.4 Timing

The data sheet provides timing at the device pin. For output timing analysis, the tester pin electronics and its transmission line effects must be taken into account. [Figure 6-6](#) shows an equivalent test load circuit for the output under test. The load capacitance value stated is only for characterization and measurement of AC timing signals. This load capacitance value does not indicate the maximum load the device is capable of driving.

Timing reference loads are not intended as a precise representation of any particular system environment or depiction of the actual load presented by a production test. System designers should use IBIS or other simulation tools to correlate the timing reference load to a system environment. Refer to the [Section 8](#).

## 7.4 Device Functional Modes

DMD functional modes are controlled by the DLPC2607 controller. See the [DLPC2607 controller data sheet](#) or contact a TI applications engineer.

## 7.5 Window Characteristics and Optics

### 7.5.1 Optical Interface and System Image Quality

TI assumes no responsibility for end-equipment optical performance. Achieving the desired end-equipment optical performance involves making trade-offs between numerous components and system design parameters. Optimizing system optical performance and image quality strongly relates to optical system design parameter trades. Although it is not possible to anticipate every conceivable application, projector image quality and optical performance depends on compliance with the optical system operating conditions described in the following sections.

#### 7.5.1.1 Numerical Aperture and Stray Light Control

The angle defined by the numerical aperture of the illumination and projection optics at the DMD optical area should be the same. This angle should not exceed the nominal device mirror tilt angle unless appropriate apertures are added in the illumination and/or projection pupils to block out flat-state and stray light from the projection lens. The mirror tilt angle defines DMD capability to separate the "ON" optical path from any other light path, including undesirable flat-state specular reflections from the DMD window, DMD border structures, or other system surfaces near the DMD such as prism or lens surfaces. If the numerical aperture exceeds the mirror tilt angle, or if the projection numerical aperture angle is more than two degrees larger than the illumination numerical aperture angle, objectionable artifacts in the display's border and/or active area could occur.

#### 7.5.1.2 Pupil Match

TI's optical and image quality specifications assume that the exit pupil of the illumination optics is nominally centered within two degrees of the entrance pupil of the projection optics. Misalignment of pupils can create objectionable artifacts in the display's border as well as the active area, which may require additional system apertures to control, especially if the numerical aperture of the system exceeds the pixel tilt angle.

### 7.5.1.3 Illumination Overfill

The active area of the device is surrounded by an aperture on the inside DMD window surface that masks structures of the DMD chip assembly from normal view, and is sized to anticipate several optical operating conditions. Overfill light illuminating the area outside the active array can create artifacts from the mechanical features surrounding the active array and other surface anomalies that may be visible on the screen. The illumination optical system should be designed to limit light flux incident anywhere outside more than 20 pixels from the edge of the active array on all sides. Depending on the particular system's optical architecture and assembly tolerances, this amount of overfill light on the outside of the active array may still cause artifacts to still be visible.

## 7.6 Micromirror Array Temperature Calculation

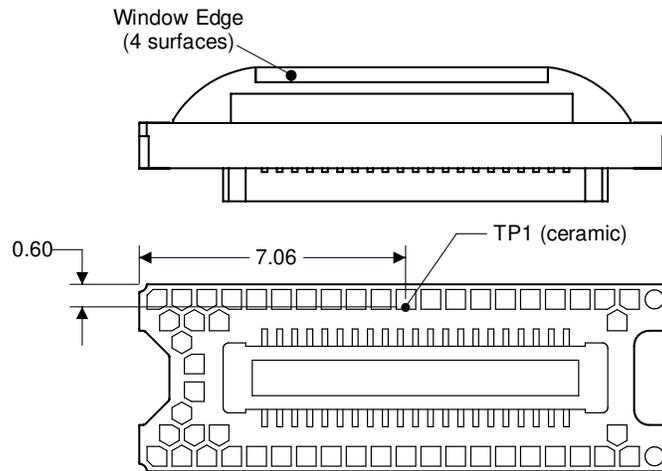


图 7-1. DMD Thermal Test Point

The micromirror array temperature can be computed analytically from measurement points on the outside of the package, the package thermal resistance, the electrical power dissipation, and the illumination heat load. The relationship between array temperature and the reference ceramic temperature is provided by the following equations:

$$T_{\text{ARRAY}} = T_{\text{CERAMIC}} + (Q_{\text{ARRAY}} \times R_{\text{ARRAY - TO - CERAMIC}}) \quad (1)$$

$$Q_{\text{ARRAY}} = Q_{\text{ELECTRICAL}} + Q_{\text{ILLUMINATION}} \quad (2)$$

$$Q_{\text{ILLUMINATION}} = (C_{\text{L2W}} \times \text{SL}) \quad (3)$$

- $T_{\text{ARRAY}}$  = Computed DMD array temperature (°C)
- $T_{\text{CERAMIC}}$  = Measured ceramic temperature (°C), TP1 location in 图 7-1
- $R_{\text{ARRAY - TO - CERAMIC}}$  = DMD package thermal resistance from array to outside ceramic (°C/W), specified in 节 6.5
- $Q_{\text{ARRAY}}$  = Total DMD power; electrical plus absorbed (calculated) (W)
- $Q_{\text{ELECTRICAL}}$  = Nominal DMD electrical power dissipation (W)
- $C_{\text{L2W}}$  = Conversion constant for screen lumens to absorbed optical power on the DMD (W/lm)
- $\text{SL}$  = Measured ANSI screen lumens (lm)

The electrical power dissipation of the DMD is variable and depends on the voltages, data rates, and operating frequencies. A nominal electrical power dissipation to use when calculating array temperature is 0.045 watts. The absorbed power from the illumination source is variable and depends on the operating state of the mirrors and the intensity of the light source. The equations shown previously are valid for a 1-Chip DMD system with a total projection efficiency from DMD to screen of 87%.

The conversion constant  $C_{L2W}$  is based on DMD micromirror array characteristics. It assumes a spectral efficiency of 300 lumens/watt for the projected light, and an illumination distribution of 83.7% on the DMD active array and 16.3% on the DMD array border and window aperture. The conversion constant is calculated to be 0.00293 W/lm.

The following is a sample calculation for a typical projection application:

- $SL = 20 \text{ lm}$
- $T_{\text{Ceramic}} = 55^\circ\text{C}$
- $Q_{\text{Array}} = Q_{\text{ELECTRICAL}} + Q_{\text{ILLUMINATION}} = 0.045 \text{ W} + (0.00293 \text{ W/lm} \times 20 \text{ lm}) = 0.1036 \text{ W}$
- $T_{\text{Array}} = 55^\circ\text{C} + (0.1036 \text{ W} \times 8^\circ\text{C/W}) = 55.8^\circ\text{C}$

## 7.7 Micromirror Landed-On/Landed-Off Duty Cycle

### 7.7.1 Definition of Micromirror Landed-On/Landed-Off Duty Cycle

The micromirror landed-on/landed-off duty cycle (landed duty cycle) denotes the amount of time (as a percentage) that an individual micromirror is landed in the On state versus the amount of time the same micromirror is landed in the Off state.

As an example, a landed duty cycle of 75/25 indicates that the referenced pixel is in the On state 75% of the time (and in the Off state 25% of the time), whereas 25/75 would indicate that the pixel is in the On state 25% of the time. Likewise, 50/50 indicates that the pixel is On 50% of the time and Off 50% of the time.

Note that when assessing landed duty cycle, the time spent switching from one state (ON or OFF) to the other state (OFF or ON) is considered negligible and is thus ignored.

Since a micromirror can only be landed in one state or the other (On or Off), the two numbers (percentages) always add to 100.

### 7.7.2 Landed Duty Cycle and Useful Life of the DMD

Knowing the long-term average landed duty cycle (of the end product or application) is important because subjecting all (or a portion) of the DMD's micromirror array (also called the active array) to an asymmetric landed duty cycle for a prolonged period of time can reduce the DMD's usable life.

Note that it is the symmetry/asymmetry of the landed duty cycle that is of relevance. The symmetry of the landed duty cycle is determined by how close the two numbers (percentages) are to being equal. For example, a landed duty cycle of 50/50 is perfectly symmetrical whereas a landed duty cycle of 100/0 or 0/100 is perfectly asymmetrical.

### 7.7.3 Landed Duty Cycle and Operational DMD Temperature

Operational DMD Temperature and Landed Duty Cycle interact to affect the DMD's usable life, and this interaction can be exploited to reduce the impact that an asymmetrical Landed Duty Cycle has on the DMD's usable life. This is quantified in the de-rating curve shown in [Figure 6-1](#). The importance of this curve is that:

- All points along this curve represent the same usable life.
- All points above this curve represent lower usable life (and the further away from the curve, the lower the usable life).
- All points below this curve represent higher usable life (and the further away from the curve, the higher the usable life).

In practice, this curve specifies the Maximum Operating DMD Temperature that the DMD should be operated at for a given long-term average Landed Duty Cycle.

### 7.7.4 Estimating the Long-Term Average Landed Duty Cycle of a Product or Application

During a given period of time, the Landed Duty Cycle of a given pixel follows from the image content being displayed by that pixel.

For example, in the simplest case, when displaying pure-white on a given pixel for a given time period, that pixel will experience a 100/0 Landed Duty Cycle during that time period. Likewise, when displaying pure-black, the pixel will experience a 0/100 Landed Duty Cycle.

Between the two extremes (ignoring for the moment color and any image processing that may be applied to an incoming image), the Landed Duty Cycle tracks one-to-one with the gray scale value, as shown in [表 7-1](#).

**表 7-1. Grayscale Value  
and Landed Duty Cycle**

| Grayscale Value | Landed Duty Cycle |
|-----------------|-------------------|
| 0%              | 0/100             |
| 10%             | 10/90             |
| 20%             | 20/80             |
| 30%             | 30/70             |
| 40%             | 40/60             |
| 50%             | 50/50             |
| 60%             | 60/40             |
| 70%             | 70/30             |
| 80%             | 80/20             |
| 90%             | 90/10             |
| 100%            | 100/0             |

Accounting for color rendition (but still ignoring image processing) requires knowing both the color intensity (from 0% to 100%) for each constituent primary color (red, green, and/or blue) for the given pixel as well as the color cycle time for each primary color, where “color cycle time” is the total percentage of the frame time that a given primary must be displayed in order to achieve the desired white point.

During a given period of time, the landed duty cycle of a given pixel can be calculated as follows:

$$\text{Landed Duty Cycle} = (\text{Red\_Cycle\_}\% \times \text{Red\_Scale\_Value}) + (\text{Green\_Cycle\_}\% \times \text{Green\_Scale\_Value}) + (\text{Blue\_Cycle\_}\% \times \text{Blue\_Scale\_Value}) \quad (4)$$

where

- Red\_Cycle\_%, Green\_Cycle\_%, and Blue\_Cycle\_% represent the percentage of the frame time that Red, Green, and Blue are displayed (respectively) to achieve the desired white point.

For example, assume that the red, green and blue color cycle times are 50%, 20%, and 30% respectively (in order to achieve the desired white point), then the Landed Duty Cycle for various combinations of red, green, blue color intensities would be as shown in [表 7-2](#).

**表 7-2. Example Landed Duty Cycle for Full-Color  
Pixels**

| Red Cycle Percentage | Green Cycle Percentage | Blue Cycle Percentage |
|----------------------|------------------------|-----------------------|
| 50%                  | 20%                    | 30%                   |

| Red Scale Value | Green Scale Value | Blue Scale Value | Landed Duty Cycle |
|-----------------|-------------------|------------------|-------------------|
| 0%              | 0%                | 0%               | 0/100             |
| 100%            | 0%                | 0%               | 50/50             |
| 0%              | 100%              | 0%               | 20/80             |
| 0%              | 0%                | 100%             | 30/70             |
| 12%             | 0%                | 0%               | 6/94              |
| 0%              | 35%               | 0%               | 7/93              |
| 0%              | 0%                | 60%              | 18/82             |
| 100%            | 100%              | 0%               | 70/30             |
| 0%              | 100%              | 100%             | 50/50             |
| 100%            | 0%                | 100%             | 80/20             |
| 12%             | 35%               | 0%               | 13/87             |
| 0%              | 35%               | 60%              | 25/75             |
| 12%             | 0%                | 60%              | 24/76             |
| 100%            | 100%              | 100%             | 100/0             |

## 8 Application and Implementation

### 备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

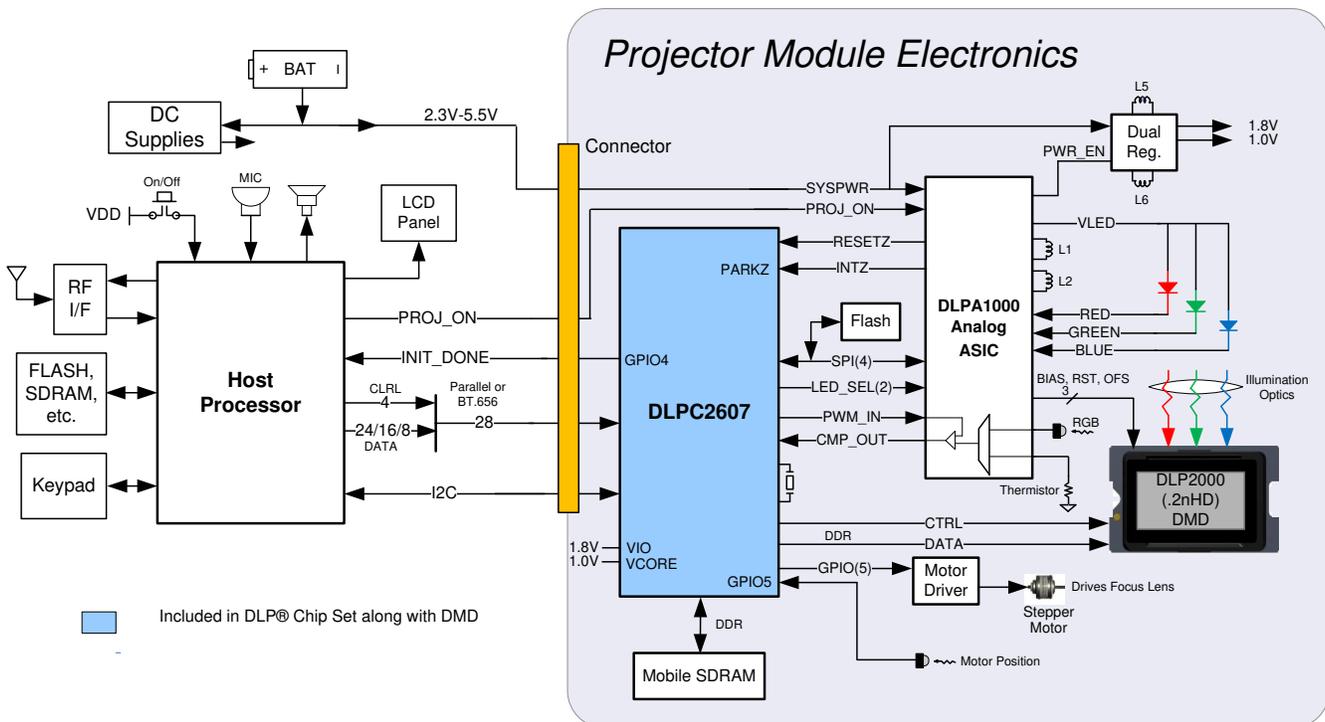
### 8.1 Application Information

The DMDs are spatial light modulators which reflect incoming light from an illumination source to one of two directions, with the primary direction being into projection or collection optics. Each application is derived primarily from the optical architecture of the system and the format of the data coming into the the DLPC2607 controller. Applications of interest include internet of things (IoT) devices such as control panels, and security systems and thermostats, as well as projection embedded in display applications like smartphones, tablets, cameras, and artificial intelligence (AI) assistance. Other applications include wearable (near-eye) displays, micro digital signage, and ultra-low power smart accessory projectors.

DMD power-up and power-down sequencing is strictly controlled by the DLPA1000. Refer to 节 9 for power-up and power-down specifications. The DLP2000 DMD reliability is only specified when used with the DLPC2607 controller and the DLPA1000 PMIC/LED Driver.

### 8.2 Typical Application

A common application for the DLP2000 chipset is creating a pico-projector embedded in a handheld product. For example, a pico-projector embedded in a smart phone, camera, battery powered mobile accessory, micro digital signage or IoT application. The DLPC2607 controller in the pico-projector receives images from a multimedia front end within the product as shown below.



#### 8.2.1 Design Requirements

A pico-projector is created by using a DLP chip set comprised of the DLP2000 DMD, a DLPC2607 controller, and a DLPA1000 PMIC/LED driver. The DLPC2607 controller does the digital image processing, the DLPA1000 provides the needed analog functions for the projector, and the DLP2000 DMD is the display device producing the projected image.

In addition to the three DLP chips in the chipset, other chips may be needed. This includes a Flash part needed to store the software and firmware for controlling the DLPC2607 controller.

The illumination that is applied to the DMD is typically from red, green, and blue LEDs. These are often contained in three separate packages, but sometimes more than one color of LED die may be in the same package to reduce the overall size of the pico-projector.

When connecting the DLPC2607 controller to the multimedia front end to receive images, a parallel interface is used. When using the parallel interface, the I<sup>2</sup>C should be connected to the multimedia front end to send commands to the DLPC2607 controller and configure the DLPC2607 controller for different features.

### 8.2.2 Detailed Design Procedure

To connect the DLPC2607 controller, the DLPA1000, and the DLP2000 DMD, see the reference design schematic. A small circuit board layout is possible when using this schematic. An example small board layout is included in the reference design data base. Layout guidelines should be followed to achieve a reliable projector. An optical OEM who specializes in designing optics for DLP projectors typically supplies the optical engine that has the LED packages and the DMD mounted on it.

### 8.2.3 Application Curve

As the LED currents that are driven time-sequentially through the red, green, and blue LEDs are increased, the brightness of the projector increases. This increase is somewhat non-linear, and the curve for typical white screen lumens changes with LED currents is as shown in [Figure 8-1](#). For the LED currents shown, it is assumed that the same current amplitude is applied to the red, green, and blue LEDs.

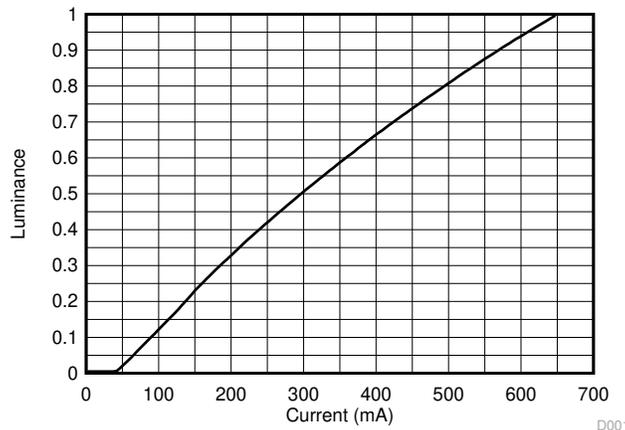


图 8-1. Luminance vs Current

## 9 Power Supply Recommendations

The following power supplies are all required to operate the DMD:  $V_{SS}$ ,  $V_{CC}$ ,  $V_{OFFSET}$ ,  $V_{BIAS}$ , and  $V_{RESET}$ . DMD power-up and power-down sequencing is strictly controlled by the DLPA1000 device.

$V_{CC}$ ,  $V_{OFFSET}$ ,  $V_{BIAS}$ , and  $V_{RESET}$  power supplies have to be coordinated during power-up and power-down operations. Failure to meet any of the following requirements will result in a significant reduction in the DMD's reliability and lifetime. Refer to [Figure 9-1](#).

### CAUTION

For reliable operation of the DMD, the following power supply sequencing requirements must be followed. Failure to adhere to the prescribed power-up and power-down procedures may affect device reliability.

$V_{CC}$ ,  $V_{OFFSET}$ ,  $V_{BIAS}$ , and  $V_{RESET}$  power supplies have to be coordinated during power-up and power-down operations. Failure to meet any of the following requirements will result in a significant reduction in the DMD's reliability and lifetime.

### 9.1 Power Supply Power-Up Procedure

- During Power-Up,  $V_{CC}$  must always start and settle before  $V_{OFFSET}$ ,  $V_{BIAS}$ , and  $V_{RESET}$  voltages are applied to the DMD.
- During Power-Up,  $V_{BIAS}$  does not have to start after  $V_{OFFSET}$ . However, it is a strict requirement that the delta between  $V_{BIAS}$  and  $V_{OFFSET}$  must be within  $\pm 8.75$  V (Note 1).
- During Power-Up, the DMD's LVCMOS input pins shall not be driven high until after  $V_{CC}$  has settled at operating voltage.
- During Power-Up, there is no requirement for the relative timing of  $V_{RESET}$  with respect to  $V_{OFFSET}$  and  $V_{BIAS}$ .
- Slew Rates for Power-Up are flexible, as long as the transient voltage levels follow the requirements listed previously.

### 9.2 Power Supply Power-Down Procedure

- The power-down sequence is the reverse order of the previous power-up sequence.  $V_{CC}$  must be supplied until after  $V_{BIAS}$ ,  $V_{RESET}$  and  $V_{OFFSET}$  are discharged to within 4 V of ground.
- During Power-Down, it is not mandatory to stop driving  $V_{BIAS}$  prior to  $V_{OFFSET}$ , but it is a strict requirement that the delta between  $V_{BIAS}$  and  $V_{OFFSET}$  must be within  $\pm 8.75$  V (Note 1).
- During power-down, the DMD's LVCMOS input pins must be less than  $V_{CC} + 0.3$  V.
- During power-down, there is no requirement for the relative timing of  $V_{RESET}$  with respect to  $V_{OFFSET}$  and  $V_{BIAS}$ .
- Slew rates for power-down are flexible, as long as the transient voltage levels follow the requirements listed previously.

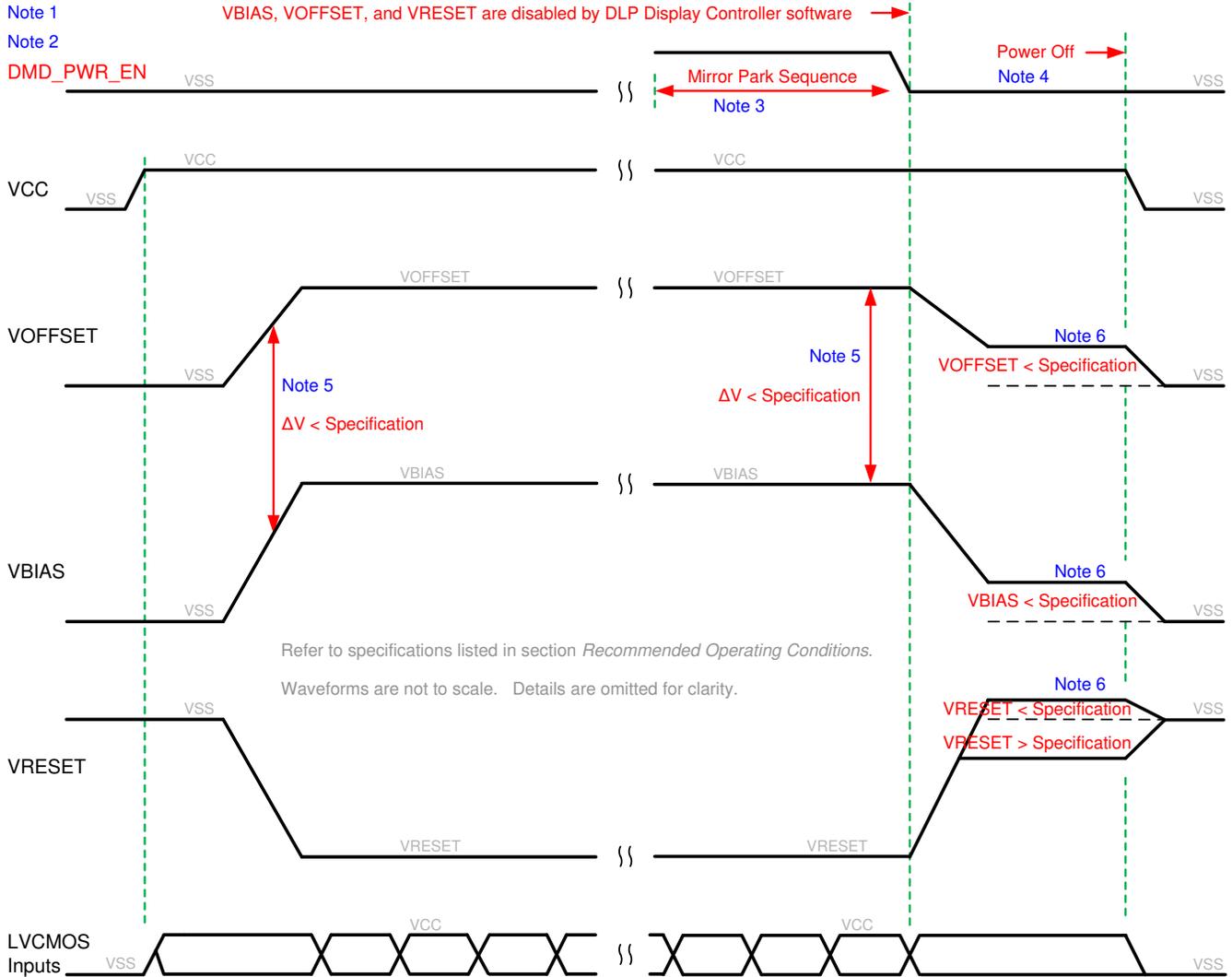


图 9-1. DMD Power Supply Sequencing Requirements

Note 1: Refer to specifications listed in 节 6.4 . Waveforms are not to scale. Details are omitted for clarity.

Note 2: DMD\_PWR\_EN is not a package pin on the DMD. It is a signal from the DLP Display Controller (DLPC2607) that enables the  $V_{\text{RESET}}$ ,  $V_{\text{BIAS}}$ , and  $V_{\text{OFFSET}}$  regulators on the system board.

Note 3: After the DMD micromirror park sequence is complete, the DLP display controller (DLPC2607) software initiates a hardware power-down that disables  $V_{\text{BIAS}}$ ,  $V_{\text{RESET}}$  and  $V_{\text{OFFSET}}$ .

Note 4: During the micromirror parking process,  $V_{\text{CC}}$ ,  $V_{\text{BIAS}}$ ,  $V_{\text{OFFSET}}$ , and  $V_{\text{RESET}}$  power supplies are all required to be within the specification limits in 节 6.4 . Once the micromirrors are parked,  $V_{\text{BIAS}}$ ,  $V_{\text{OFFSET}}$ , and  $V_{\text{RESET}}$  power supplies can be turned off.

Note 5: To prevent excess current, the supply voltage delta  $|V_{\text{BIAS}} - V_{\text{OFFSET}}|$  must be less than specified in 节 6.4 . It is critical to meet this requirement and that  $V_{\text{BIAS}}$  not reach full power level until after  $V_{\text{OFFSET}}$  is at almost full power level. OEMs may find that the most reliable way to ensure this is to delay powering  $V_{\text{BIAS}}$  until after  $V_{\text{OFFSET}}$  is fully powered on during power-up (and to remove  $V_{\text{BIAS}}$  prior to  $V_{\text{OFFSET}}$  during power down). In this case,  $V_{\text{OFFSET}}$  is run at its maximum allowable voltage level (8.75 V).

Note 6: Refer to specifications listed in 表 9-1.

**表 9-1. DMD Power-Down Sequence Requirements**

| PARAMETER           | DESCRIPTION                                     | MIN   | MAX | UNIT |
|---------------------|---|-------|-----|------|
| V <sub>BIAS</sub>   | Supply voltage level during power-down sequence |       | 4.0 | V    |
| V <sub>OFFSET</sub> | Supply voltage level during power-down sequence |       | 4.0 | V    |
| V <sub>RESET</sub>  | Supply voltage level during power-down sequence | - 4.0 | 0.5 | V    |

## 10 Layout

### 10.1 Layout Guidelines

There are no specific layout guidelines for the DMD, however the DMD is typically connected using a board to board connector with a flex cable. The flex cable provides an interface for data and control signals between the DLPC2607 controller and the DLP2000 DMD. For detailed layout guidelines refer to the DLPC2607 controller layout guidelines under PCB design and DMD interface considerations.

Some layout guidelines for the flex cable interface with the DMD are:

- Minimize the number of layer changes for DMD data and control signals.
- DMD data and control lines are DDR, whereas DMD\_SAC and DMD\_DRC lines are single data rate. Matching the DDR lines is more critical and should take precedence over matching single data rate lines.
- [图 10-1](#) and [图 10-2](#) show the top and bottom layer of the DMD flex cable connections.

### 10.2 Layout Example

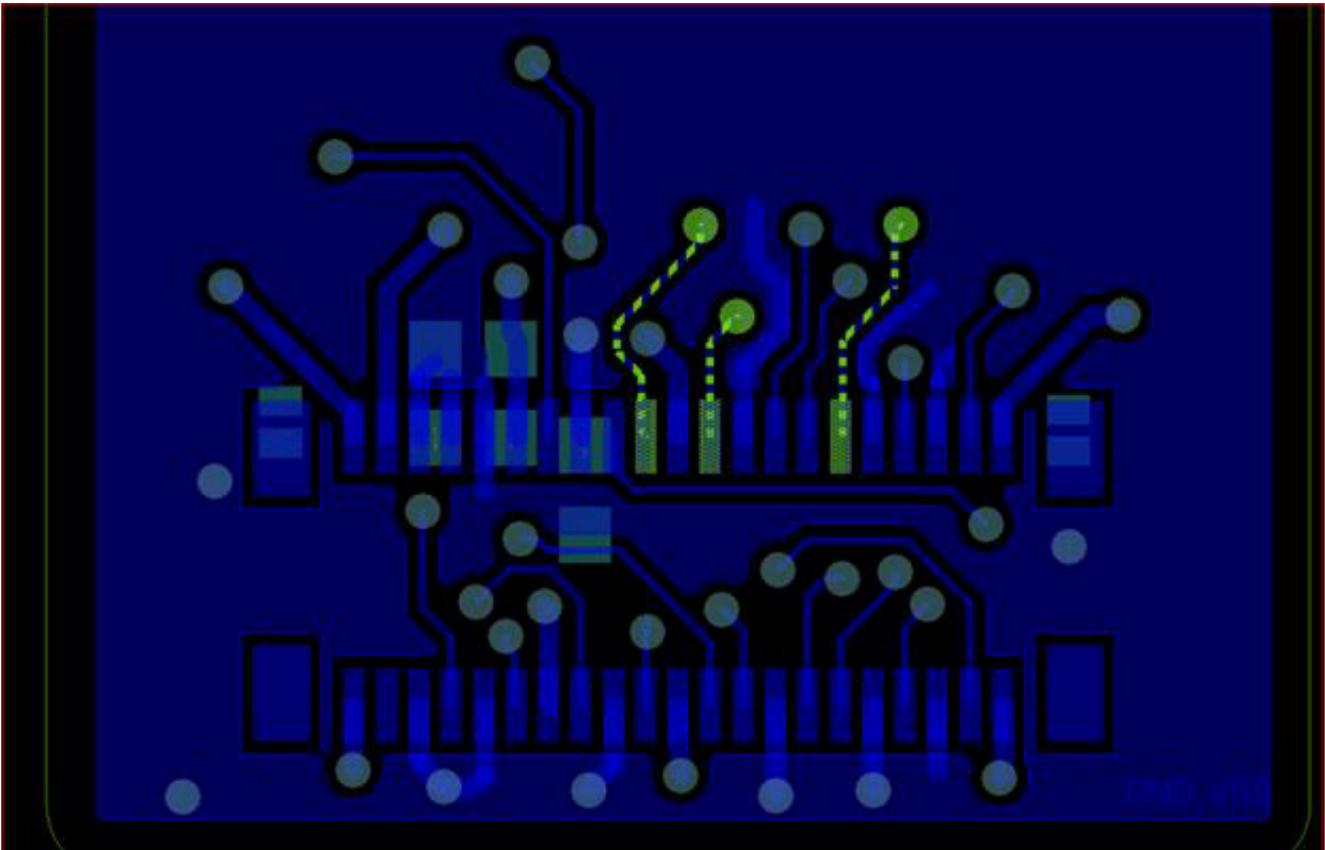


图 10-1. DMD Flex Cable—Top Layer

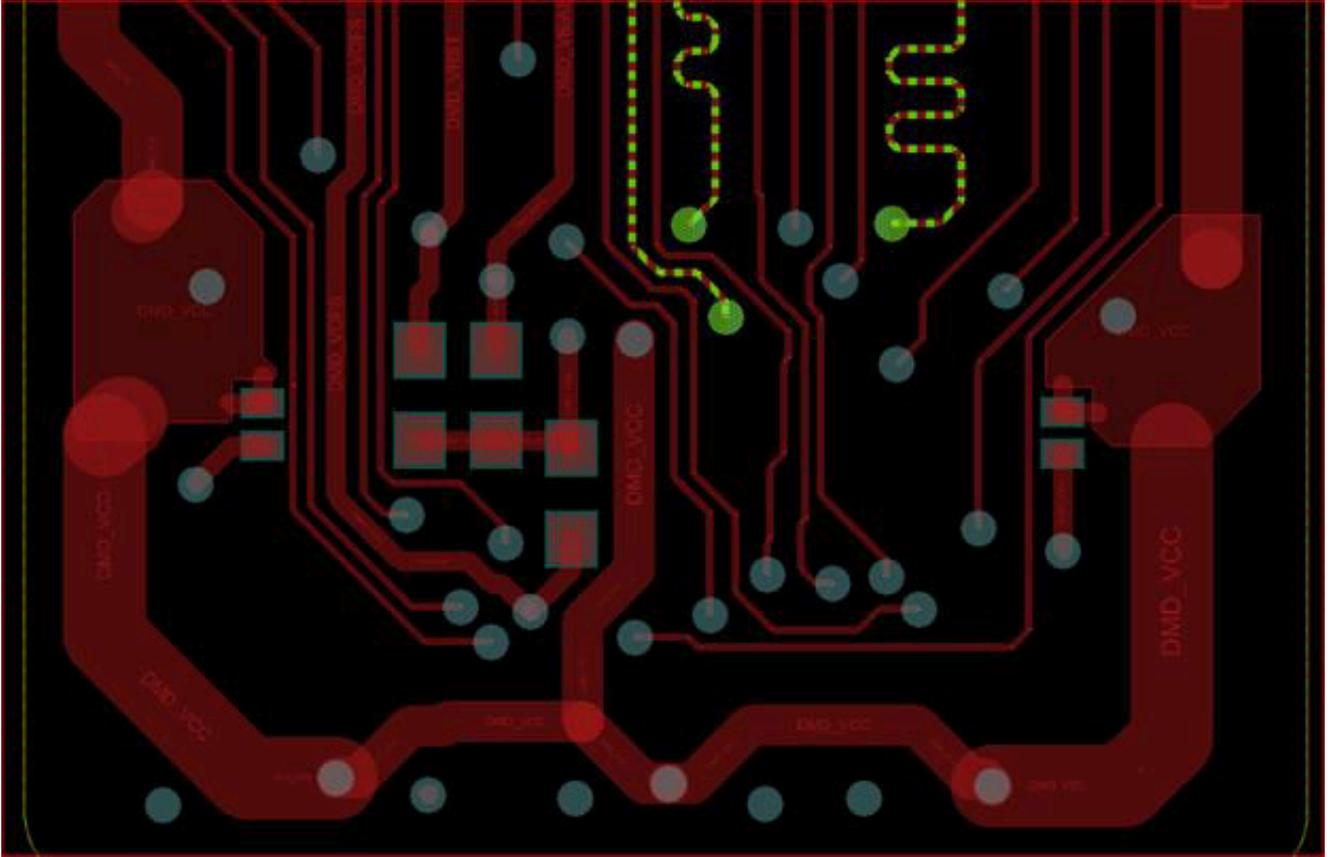


图 10-2. DMD Flex Cable—Bottom Layer

## 11 Device and Documentation Support

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### 11.2 Device Support

#### 11.2.1 Device Nomenclature

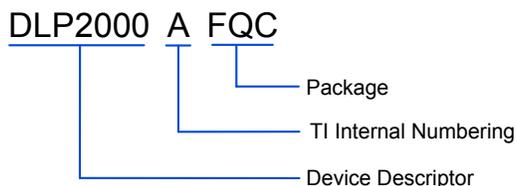


图 11-1. Part Number Description

#### 11.2.2 Device Markings

- Device Marking includes the Human-Readable character string GHJJJK VVVV
- GHJJJK is the Lot Trace Code
- VVVV is a 4 character Encoded Device Part Number

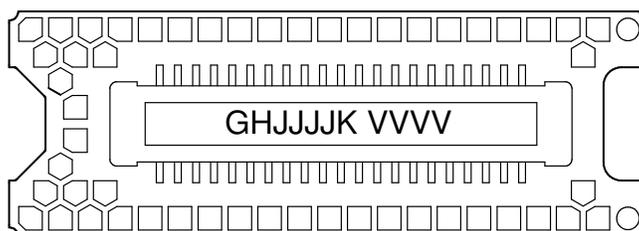


图 11-2. DMD Marking Location

### 11.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

表 11-1. Related Links

| PARTS    | PRODUCT FOLDER             | SAMPLE & BUY               | TECHNICAL DOCUMENTS        | TOOLS & SOFTWARE           | SUPPORT & COMMUNITY        |
|----------|----------------------------|----------------------------|----------------------------|----------------------------|----------------------------|
| DLPC2607 | <a href="#">Click here</a> |
| DLPA1000 | <a href="#">Click here</a> |

### 11.4 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](http://ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 11.5 支持资源

**TI E2E™ 支持论坛** 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

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## 11.7 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 11.8 术语表

### TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

| Orderable part number | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier  | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|-----------------------|---------------|----------------------|-----------------|------------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| DLP2000AFQC.B         | NRND          | Production           | CLGA (FQC)   42 | 180   JEDEC TRAY (5+1) | Yes         | Call TI                              | N/A for Pkg Type                  | 0 to 70      |                     |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

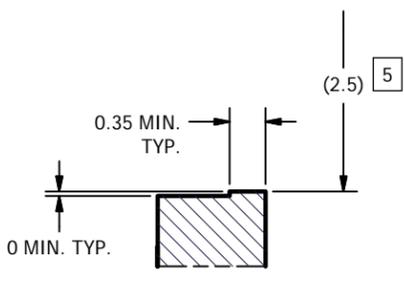
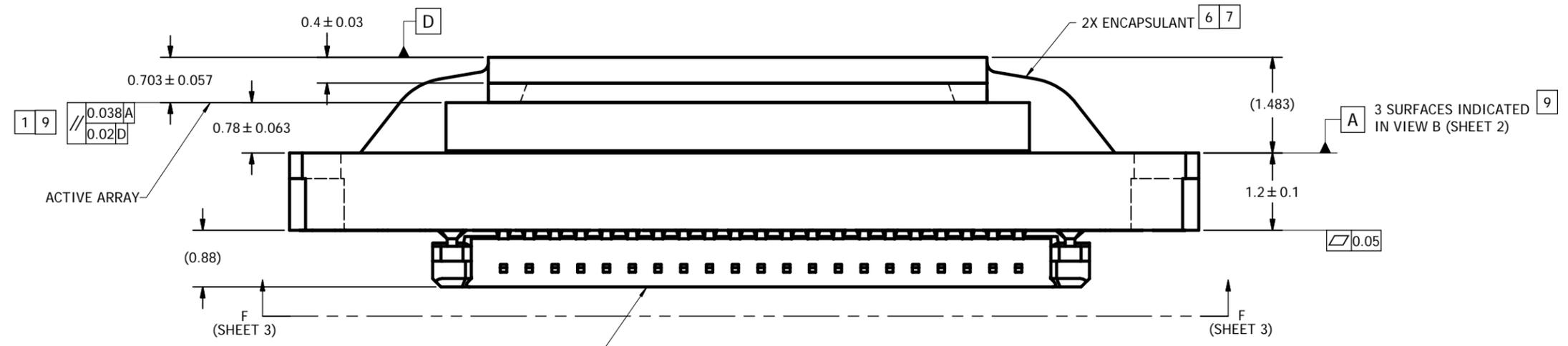
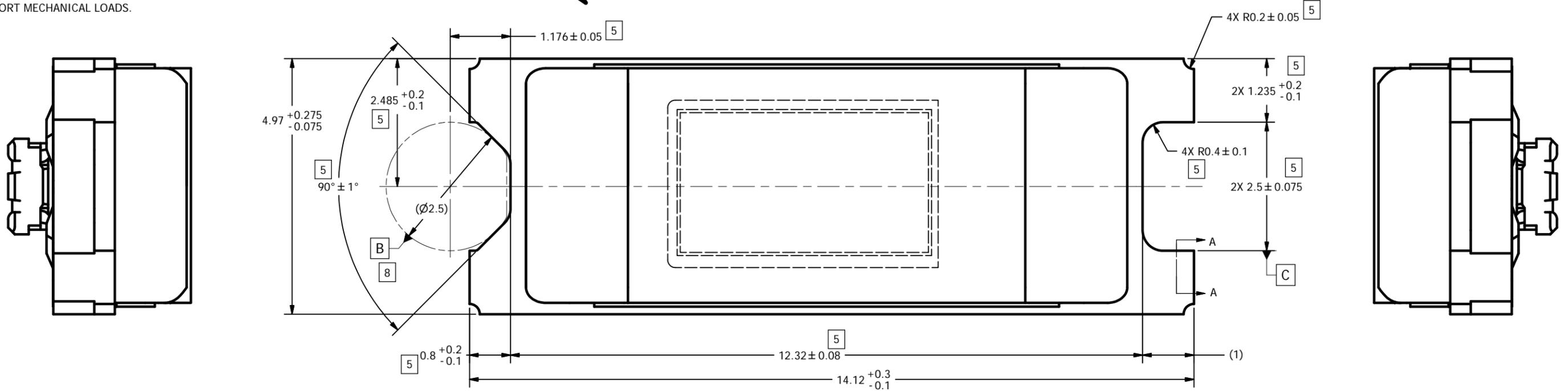
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| REVISIONS |  |          |     |
|-----------|--|----------|-----|
| REV       | DESCRIPTION  | DATE     | BY  |
| A         | ECO 2100735 INITIAL RELEASE  | 8/3/09   | BMH |
| B         | ECO 2102356 ADD DATUM E AND NOTE 9; UPDATE SOLDER APPEARANCE; TIGHTEN NOTCH X-AXIS TOL'S | 10/22/09 | BMH |
| C         | ECO 2104056 CHG ENCAP MAX HEIGHT FROM TBD TO ZERO  | 1/4/10   | BMH |
| D         | ECO 2166625 ADD "FQC PACKAGE" TO DRAWING TITLE; SHOW APERTURE CORNER RADII PICTORIALLY   | 5/30/17  | BMH |

- NOTES UNLESS OTHERWISE SPECIFIED:
- 1 DIE PARALLELISM TOLERANCE APPLIES TO DMD ACTIVE ARRAY ONLY.
  - 2 ROTATION ANGLE OF DMD ACTIVE ARRAY IS A REFINEMENT OF THE LOCATION TOLERANCE AND HAS A MAXIMUM ALLOWED VALUE OF 0.6 DEGREES.
  - 3 BOUNDARY MIRRORS SURROUNDING THE DMD ACTIVE ARRAY.
  - 4 DMD MARKING TO APPEAR IN CONNECTOR RECESS.
  - 5 NOTCH DIMENSIONS ARE DEFINED BY UPPERMOST LAYERS OF CERAMIC, AS SHOWN IN SECTION A-A.
  - 6 ENCAPSULANT TO BE CONTAINED WITHIN DIMENSIONS SHOWN IN VIEW C (SHEET 2). NO ENCAPSULANT IS ALLOWED ON TOP OF THE WINDOW.
  - 7 ENCAPSULANT NOT TO EXCEED THE HEIGHT OF THE WINDOW.
  - 8 DATUM B IS DEFINED BY A DIA. 2.5 PIN, WITH A FLAT ON THE SIDE FACING TOWARD THE CENTER OF THE ACTIVE ARRAY, AS SHOWN IN VIEW B (SHEET 2).
  - 9 WHILE ONLY THE THREE DATUM A TARGET AREAS A1, A2, AND A3 ARE USED FOR MEASUREMENT, ALL 4 CORNERS SHOULD BE CONTACTED, INCLUDING E1, TO SUPPORT MECHANICAL LOADS.

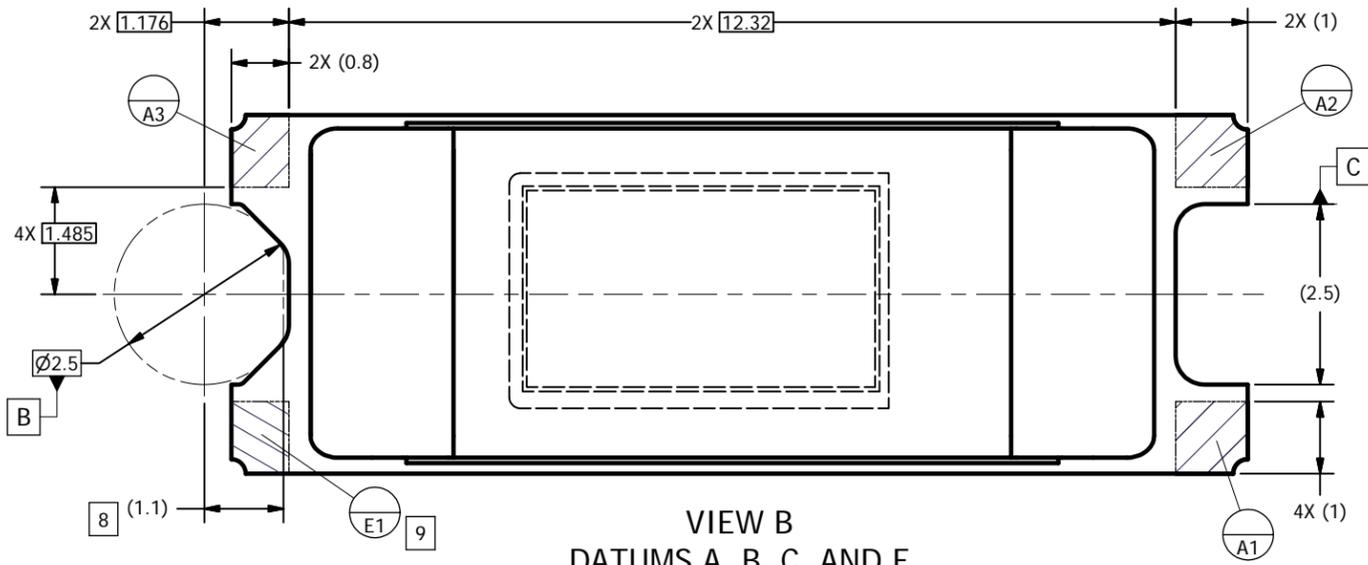


(PANASONIC AXT642124DD1, 42-CONTACT, 0.4 mm PITCH BOARD-TO-BOARD HEADER) INTERFACE TO PANASONIC AXT542124DD1 SOCKET

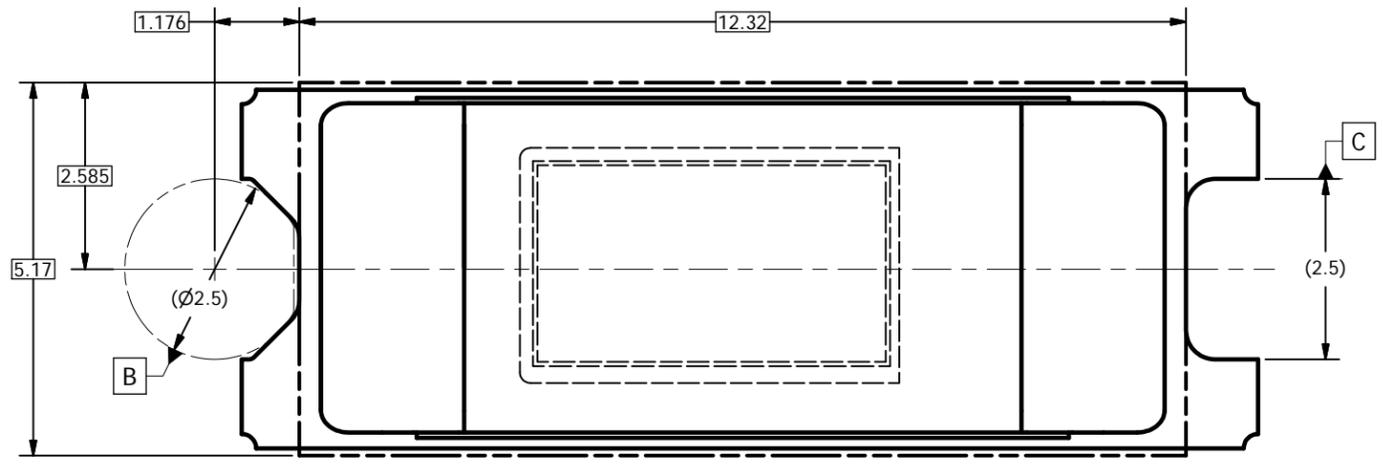
|  |                |
|--|----------------|
| UNLESS OTHERWISE SPECIFIED                                 |                |
| ● DIMENSIONS ARE IN MILLIMETERS                            |                |
| ● TOLERANCES:  |                |
| ANGLES ± 1°  |                |
| 2 PLACE DECIMALS ± 0.25                                    |                |
| 1 PLACE DECIMALS ± 0.50                                    |                |
| ● DIMENSIONAL LIMITS APPLY BEFORE PROCESSES                |                |
| ● INTERPRET DIMENSIONS IN ACCORDANCE WITH ASME Y14.5M-1994 |                |
| ● REMOVE ALL BURRS AND SHARP EDGES                         |                |
| ● PARENTHETICAL INFORMATION FOR REFERENCE ONLY             |                |
| THIRD ANGLE PROJECTION                                     | NONE           |
| APPLICATION  | 0314DA USED ON |

|              |          |
|--------------|----------|
| DRAWN        | DATE     |
| B. HASKETT   | 8/3/2009 |
| ENGINEER     |          |
| B. HASKETT   | 8/3/2009 |
| QA/CE        |          |
| P. KONRAD    | 8/3/2009 |
| CM           |          |
| F. ARMSTRONG | 8/3/2009 |
| APPROVED     |          |
| J. GRIMMETT  | 8/3/2009 |

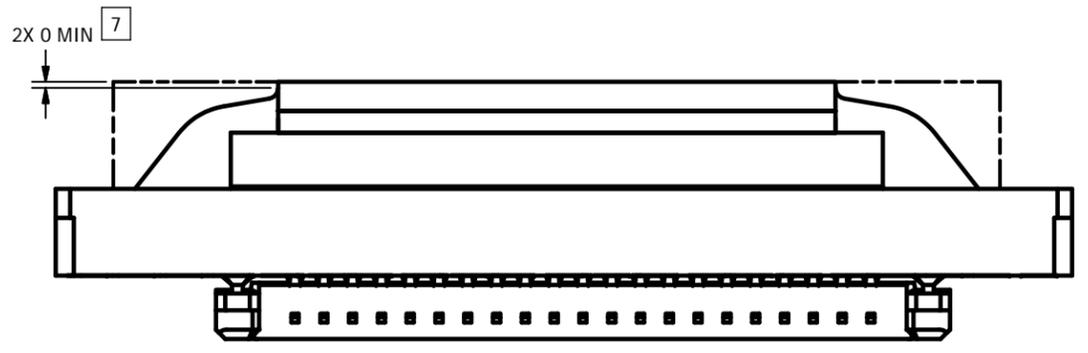
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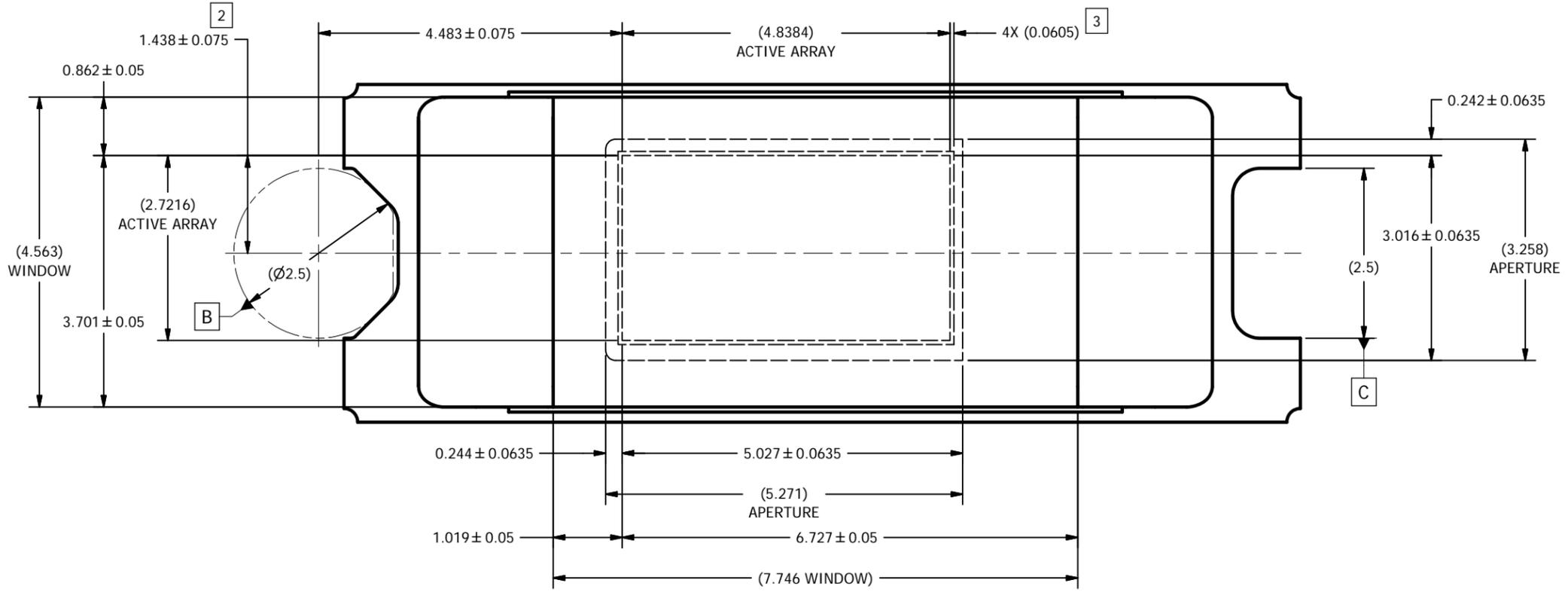
**VIEW B**  
 DATUMS A, B, C, AND E  
 SCALE 20 : 1  
 (FROM SHEET 1)



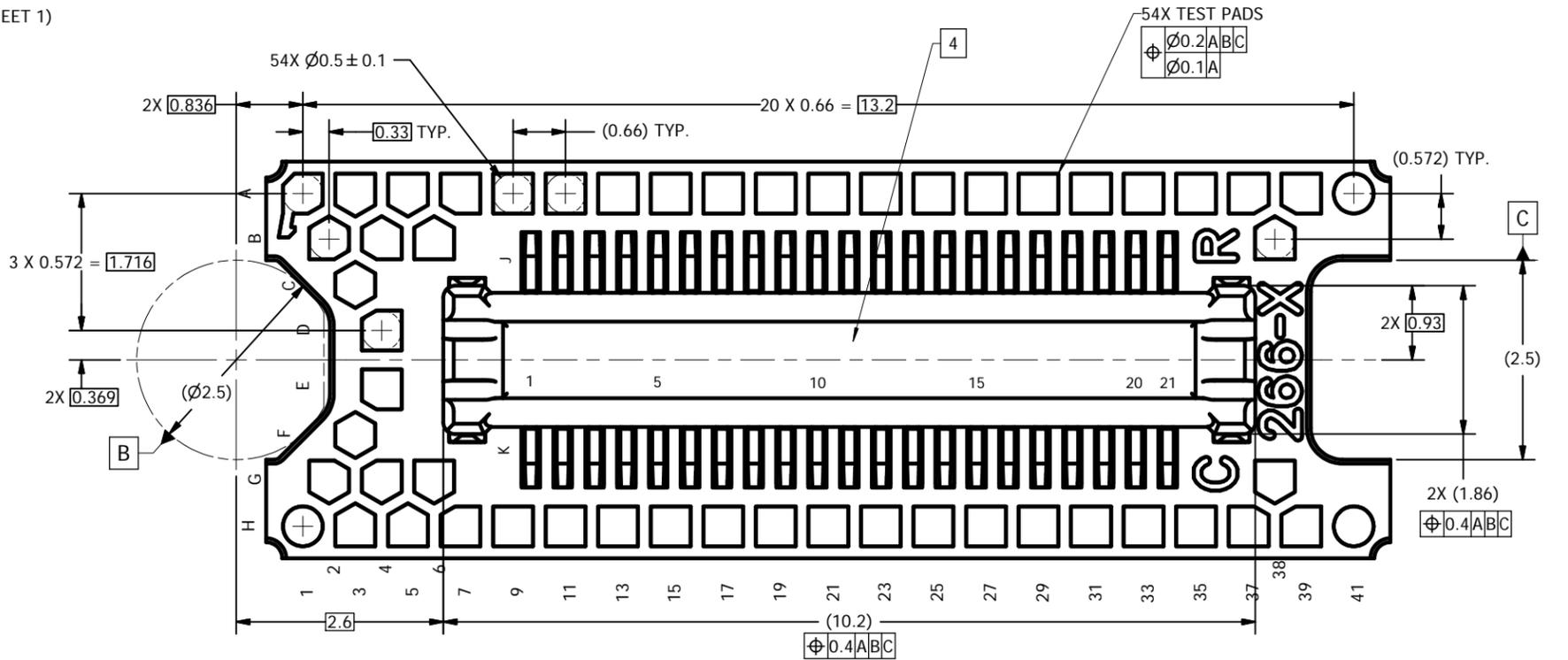
**VIEW C** 6  
 ENCAPSULANT MAXIMUM X/Y DIMENSIONS  
 SCALE 20 : 1  
 (FROM SHEET 1)



**VIEW D**  
 ENCAPSULANT MAXIMUM HEIGHT  
 SCALE 20 : 1



VIEW E  
WINDOW AND ACTIVE ARRAY  
(FROM SHEET 1)



VIEW F-F  
TEST PADS AND CONNECTOR  
(FROM SHEET 1)

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